JPK DP

Data Processing Software Manual

Version 4.2 10 / 2012



© 2002-2012- JPK Instruments AG all rights reserved



Nanotechnology for Life Science

Table of Contents

§ 0	Introdu	ction	1
	0.1 JPK Nan	oWizard [®] SPM and DP software	1
	0.2 JPK data	formats	1
	0.2.1	Images	1
	0.2.2	Force curves	1
	0.2.3	Force maps and QI data files	1
	0.2.4	Other data formats	2
§ 1	Softwa	re overview	3
	1.1 Starting t	he program	3
	1.2 JPK imag	ge files	3
	1.2.1	The image menu bar	3
	1.2.2	The image shortcut bar	5
	1.3 JPK Ford	e files	6
	1.3.1	The force curve menu bar	6
	1.3.2	The force curve shortcut bar	8
	1.4 Software	versions and updates	9
	1.4.1	Updating your software	10
	1.4.2	SPM software version	10
	1.5 Logging S	Settings	10
§ 2	Image f	iles and the processing window	12
§ 2	Image f 2.1 Opening	iles and the processing window	12
§ 2	Image f 2.1 Opening 2.2 The Over	iles and the processing window a JPK image file view image viewer	12 12 14
§ 2	Image f 2.1 Opening 2.2 The Over 2.3 The proc	iles and the processing window a JPK image file view image viewer essing window	12 12 14 15
§ 2	Image f 2.1 Opening 2.2 The Over 2.3 The proce 2.3.1	iles and the processing window a JPK image file rview image viewer essing window Processing and Overview windows	
§ 2	Image f 2.1 Opening 2.2 The Over 2.3 The proce 2.3.1 2.3.2	iles and the processing window a JPK image file view image viewer essing window Processing and Overview windows View panel	
§ 2	Image f 2.1 Opening 2.2 The Over 2.3 The proce 2.3.1 2.3.2 2.3.3	iles and the processing window a JPK image file rview image viewer essing window Processing and Overview windows View panel Info panel	
§ 2	Image f 2.1 Opening 2.2 The Over 2.3 The proce 2.3.1 2.3.2 2.3.3 2.3.4	iles and the processing window a JPK image file rview image viewer essing window Processing and Overview windows View panel Info panel History bar and remove operation	
§ 2	Image f 2.1 Opening 2.2 The Over 2.3 The proce 2.3.1 2.3.2 2.3.3 2.3.4 2.4 Colortabl	iiles and the processing window a JPK image file rview image viewer essing window Processing and Overview windows View panel Info panel History bar and remove operation	
§ 2	Image f 2.1 Opening 2.2 The Over 2.3 The proce 2.3.1 2.3.2 2.3.3 2.3.4 2.4 Colortabl 2.4.1	iles and the processing window a JPK image file rview image viewer essing window Processing and Overview windows View panel Info panel History bar and remove operation es Choice of colortables	12 12 14 15 15 16 17 17 18 18
§ 2	Image f 2.1 Opening 2.2 The Over 2.3 The proce 2.3.1 2.3.2 2.3.3 2.3.4 2.4 Colortabl 2.4.1 2.4.2	iiles and the processing window a JPK image file rview image viewer essing window Processing and Overview windows View panel Info panel History bar and remove operation es Choice of colortables Statistics, MinMax and Fixed Range colorizers	
§ 2	Image f 2.1 Opening 2.2 The Over 2.3 The proce 2.3.1 2.3.2 2.3.3 2.3.4 2.4 Colortabl 2.4.1 2.4.2 2.4.3	iiles and the processing window a JPK image file rview image viewer essing window Processing and Overview windows View panel Info panel History bar and remove operation es Choice of colortables Statistics, MinMax and Fixed Range colorizers Adjusting the colorizer settings	12 12 14 15 15 16 17 17 17 18 18 18 18
§ 2	Image f 2.1 Opening 2.2 The Over 2.3 The proce 2.3.1 2.3.2 2.3.3 2.3.4 2.4 Colortabl 2.4.1 2.4.2 2.4.3 2.5 Saving da	iiles and the processing window a JPK image file rview image viewer essing window Processing and Overview windows View panel Info panel History bar and remove operation es Choice of colortables Statistics, MinMax and Fixed Range colorizers Adjusting the colorizer settings ata and exporting images.	
§ 2	Image f 2.1 Opening 2.2 The Over 2.3 The proce 2.3.1 2.3.2 2.3.3 2.3.4 2.4 Colortabl 2.4.1 2.4.2 2.4.3 2.5 Saving da 2.5.1	iles and the processing window a JPK image file rview image viewer essing window Processing and Overview windows View panel Info panel History bar and remove operation es Choice of colortables Statistics, MinMax and Fixed Range colorizers Adjusting the colorizer settings ata and exporting images Save data	12 12 14 15 15 16 17 17 17 17 18 18 18 18 12
§ 2	Image f 2.1 Opening 2.2 The Over 2.3 The proce 2.3.1 2.3.2 2.3.3 2.3.4 2.4 Colortabl 2.4.1 2.4.2 2.4.3 2.5 Saving da 2.5.1 2.5.2	Files and the processing window a JPK image file rview image viewer essing window Processing and Overview windows View panel Info panel History bar and remove operation es Choice of colortables Statistics, MinMax and Fixed Range colorizers Adjusting the colorizer settings ata and exporting images Save data Export image	12 12 14 15 15 16 17 17 17 17 18 18 18 18 12
§ 2 § 3	Image f 2.1 Opening 2.2 The Over 2.3 The proce 2.3.1 2.3.2 2.3.3 2.3.4 2.4 Colortabl 2.4.1 2.4.2 2.4.3 2.5 Saving da 2.5.1 2.5.2 Data pr	iles and the processing window a JPK image file rview image viewer essing window Processing and Overview windows View panel Info panel History bar and remove operation es Choice of colortables Statistics, MinMax and Fixed Range colorizers Adjusting the colorizer settings ata and exporting images Save data Export image	12
§ 2 § 3	Image f 2.1 Opening 2.2 The Over 2.3 The proce 2.3.1 2.3.2 2.3.3 2.3.4 2.4 Colortabl 2.4.1 2.4.2 2.4.3 2.5 Saving da 2.5.1 2.5.2 Data pr 3.1 Plane fit.	iles and the processing window a JPK image file rview image viewer essing window Processing and Overview windows View panel Info panel History bar and remove operation es Choice of colortables Statistics, MinMax and Fixed Range colorizers Adjusting the colorizer settings ata and exporting images. Save data Export image. ocessing operations	
§ 2 § 3	Image f 2.1 Opening 2.2 The Over 2.3 The proce 2.3.1 2.3.2 2.3.3 2.3.4 2.4 Colortabl 2.4.1 2.4.2 2.4.3 2.5 Saving da 2.5.1 2.5.2 Data pr 3.1 Plane fit 3.2 Line fit	iles and the processing window a JPK image file rview image viewer essing window Processing and Overview windows View panel Info panel History bar and remove operation es Choice of colortables Statistics, MinMax and Fixed Range colorizers Adjusting the colorizer settings ata and exporting images Save data Export image ocessing operations	12 12 14 15 15 16 17 17 18 18 18 18 18 12 20 21 22 22 25 25 25
§ 2 § 3	Image f 2.1 Opening 2.2 The Over 2.3 The proce 2.3.1 2.3.2 2.3.3 2.3.4 2.4 Colortabl 2.4.1 2.4.2 2.4.3 2.5 Saving da 2.5.1 2.5.2 Data pr 3.1 Plane fit 3.2 Line fit 3.2.1	iles and the processing window a JPK image file view image viewer essing window Processing and Overview windows View panel Info panel History bar and remove operation es Choice of colortables Statistics, MinMax and Fixed Range colorizers Adjusting the colorizer settings ata and exporting images Save data Export image occessing operations Linefit	12 12 14 15 15 16 17 17 17 17 17 18 18 20 21 22 22 22 25 25 27



3.2.2	Histfit	
3.3 Remove	Lines	
3.4 Low and	Highpass Filters	
3.4.1	Lowpass	
3.4.2	Median filter	
3.4.3	Highpass	
3.5 Edge de	tect	
3.6 Invert im	age	
§ 4 Other i	mage tools	
4.1 Image a	nalysis tools	
4.1.1	Measure	
4.1.2	Points	
4.1.3	Section	
4.1.4	Histogram	
4.1.5	FFT	
4.2 Crop		41
4.3 3D View	· · · · · · · · · · · · · · · · · · ·	
§ 5 Direct	Overlay	
5.1.1	Opening Optical images	
5.1.2	Shift Optical Image	
5.1.3	Optical image export	
§6 Force of	curve files, processing and analysis	
6.1 Opening	a JPK force curve file	
6.2 The force	e curve window	
6.2.1	View	
6.2.2	Display toolbar and zooming	
6.2.3	Info	
6.3 Saving d	lata and exporting force curves	
6.3.1	Save and export of force data	
6.3.2	Export image	
6.4 Force cu	Irve processing operations	
6.4.1	(Re)Calibration of V-deflection	
6.4.2	Smoothing of Force Data	
6.4.3	Baseline subtraction	
6.4.4	Contact point determination	
6.4.5	Shift origin (manually offset the axes)	
6.4.6	Calculate tip-sample separation	
6.4.7	Fit a polymer chain model (FJC and WLC)	
6.4.8	Elasticity fit (Hertz models)	61
6.4.9	Step fitting	63

	6.4.10	Minimum value	67
	6.4.11	Area under the curve	68
	6.4.12	Measure the slope of the curve	68
	6.4.13	Measure distance	68
	6.4.1	Find the height corresponding to the setpoint	69
	6.4.2	Save/Load Process	70
6.	5 Batch proc	cessing	70
	6.5.1	Histogram option	75
6.	6 Filtering S	eries	76
	6.6.1	Basic Filtering	76
	6.6.2	Advanced Filtering	77
6.	7 Theory		84
	6.7.1	Elasticity fit equations for different indenter geometries	84
	6.7.2	Chain model fit	86
§ 7	Force M	aps and QI data	88
7.	1 Opening a	JPK force map or QI data file	88
	7.1.1	The force map and QI processing window	89
	7.1.2	The force map/QI data image viewer	89
	7.1.3	The spectroscopy window	
7.	2 Saving op	tions	
	7.2.1	Save Image Data	
	7.2.2	Export force maps/QI maps or force curves as picture	
	7.2.3	Save and export single force curve data	92
	7.2.4	Split map file	92
7.	3 Batch proc	cessing- Force Maps and QI data	93
§ 8	Referen	ces	



§ 0 Introduction

0.1 JPK NanoWizard[®] SPM and DP software

This manual covers the use of the DP software supplied with the JPK NanoWizard[®] AFM system. The software is designed for use on data produced during normal operation of the JPK NanoWizard[®] SPM software, and is not designed for reading in data in other formats or from other instruments.

0.2 JPK data formats

0.2.1 Images

Images produced by the JPK SPM software consist of multiple channels of data for a single scan, with a file name of the form "filename.jpk" and "qi-fit-filename.jpk-qi-image". These files will then generally be read into the DP software to produce data in a format for reading by other software programs, for instance to export images as standard TIFF files for use in presentations or reports. Other image formats are also available, note particularly the PNG format which offers lossless compression and can therefore export images that have a reasonably small file size but keep the text or lines sharp. Most of the features in DP are designed for processing images, or reading out data from image scans. In addition, some systems have software allowing calibration and import of optical images into the SPM program, using the Direct Overlay feature. In this case these same optical images can also be imported into the DP program.

0.2.2 Force curves

The force curves produced during normal spectroscopy mode are written in a compressed binary file format (file name of the form "filename.jpk-force"), so they cannot be read into normal mathematical or spreadsheet processing software programs. They contain the data of the trace and retrace segments as well as time delays or force clamp steps.

There is the possibility to export force curves as text files, either as .out files (old ASCII force format) or as a .txt file. Converting curves into .out files is not recommended, since some information will be lost (for instance, data collected during pauses and clamps, which were not supported in the old format). The text export produces normal text files containing all the curve data. The text export files cannot be read back into the DP software, all DP processing should be completed before the export.

To convert a large batch of force files, there are two scripts to convert a directory of force files. The script "jpk-force-legacy-export" creates .out files, and "jpk-force-export" creates text dump files. Both are used from the Linux terminal.

0.2.3 Force maps and QI data files

Force maps and QI data files are written in a compressed binary file format (filename.jpk-force-map, filename.jpk-qidata), in a format related to the single force files, which can only be read by the JPK Data Processing software. These files contain all the force curves of the map in the normal force format (see **Section 0.2.2** above) with the corresponding spatial information. Force maps of the old file format (filename.map_txt) can also be read in.

Once a map is read into the DP software, there are several options to save the data. It is not possible to process single curves as part of the map, but the map can be easily split into single force curves of the JPK-force or text format for further processing. There is also the possibility to export the map as a JPK force map image (filename.force)/ JPK QI image (jpk-fit-filename.jpk-qi-image), which can then be processed like a normal JPK image. Or the image can be



exported in a standard graphic format like TIFF or JPEG.

0.2.4 Other data formats

There are several other forms of data generated by the SPM software, such as real-time scans, frequency spectra from either AC mode tuning or thermal noise data, etc. These are in the form of ASCII data in columns, suitable for reading into mathematical or spreadsheet processing software programs.

§ 1 Software overview

1.1 Starting the program



Click the JPK icon labeled "DP" and the program will launch. The shortcut and menu options depend which type of file is being processed, so when the software starts, the only option is **File Open.** New menus and icons appear when a file is opened, depending on the file type.

The software can also be opened from a Linux console or shell window by typing "dp".

JPK Data Processing	
Eile	Help

1.2 JPK image files

1.2.1 The image menu bar

The image menu options appear when an image window is active, which contains all the operations available to process an image file, or measure information from an image. The following table contains an overview of the menu options with links to the relevant sections of this manual.

<u>F</u> ile	<u>E</u> dit	Manipulate	<u>M</u> easurement	<u>A</u> nalysis	<u>L</u> ayout	<u>S</u> etup	<u>W</u> indow	<u>H</u> elp			
Pull	down	menu in the	e menu-bar		Brief	Details in section:					
<u>F</u> il	е				File						
B	<u>0</u> pen			Ctrl-0	Open	and load	I JPK files			2.1	
B	Imp <u>o</u> rt	Optical Imag	e		Import	an optio	al image w	ith a correspo	onding calibration	§ 5	
A	Open <u>I</u>	<u>B</u> atch of Spec	troscopy Curves		Batch	Batch processing					
JPK	Save I	mage Data		Ctrl-S	Save	2.5.1					
PIC	Export	as Picture			Export	2.5.2					
×	Close	Frame			Close	Close current channel window					
	<u>E</u> xit			Ctrl-Q	Close	all windo	ows and exi	t DP software	9		
Ec	lit				Edit						
	Remov	e Operation	Ctrl-R		Remo	ve last p	rocessing o	peration		2.3.4	
Crop Image Select an area to crop and for								d form a new	image file	4.2	



Manipulate Image: Polynomial Line Fit Image: Histogram Line Fit Image: Subtract polynomial surface Image: Remove Lines Image: Edge Detection Image: Curvature Image: Filter	Manipulate Subtract a line fit from each scan line independently Fit polynomial to part of each scan line and subtract Subtract a plane fit from the whole image Remove selected scan lines, replacing with interpolation Highlight edges Invert the height of the current image High or low pass filtering options for the whole image	3.2.1 3.2.2 3.1 3.3 3.5 3.6 3.4
Measurement Measurement Mark Points	Measurement Measure distances and angles Measure point values	4.1.1 4.1.2
Analysis Cross Section Histogram Fourier Analysis	Analysis Open cross-section panel for measuring heights Open histogram window to show height distribution Open Fourier Analysis window for spatial frequencies	4.1.3 4.1.4 4.1.5
Layout 30 3D View <u>C</u> olortable Default Colortable	Layout Open 3D view window Change colortable for current image Change initial colortable for newly opened images	4.3
Setup Logging Settings	Setup Open the Logging Settings	1.5
Window Tile Vertically Tile Horizontally Cascade Image: Close All Frames Auto-save Window Layout Save Window Layout Save Window Layout Save Window Layout	Window Settings to allow tidy alignment of currently open windows Start/stop the automatic saving of frame properties Save the current frame properties	
Quantitative Image: qi-data-2011.12.08-17.00.29.jpk-qi-data Qverview	Reset the frame settings to delivered defaults List of currently open windows View relative location of scans in the image viewer Help	
<u>A</u> bout <u>C</u> redits	Information about the current software version	1.4.2

1.2.2 The image shortcut bar

Below the menu bar there are icons to launch the most commonly used features. These provide shortcuts for the operations available to process an image, or measure information from an image. Processing operations grouped together on the left hand side, measuring operations grouped on the right hand side. A short explanation for each icon is shown in the table below.

		3 D												
Shortcut icon	Brief explanation	Details in Section:												
	Open and load JPK files													
	Import optical images with a corresponding calibration (when available)													
	Open a batch process of force curves													
JPK	Save modified JPK file for current channel	2.5.1												
	Open the Overview image viewer to show AFM and optical images and force curves together	2.2												
PIC	Export current channel view as a TIFF image	2.5.2												
-	Remove last processing operation	2.3.4												
	Subtract a linear/ polynomial fit from each scan line independently	3.2.1												
	Fit a polynomial to a selected height range of each scan line and subtract from each line independently	3.2.2												
	Filter by replacing pixels with the median value of neighboring pixels	3.4.2												
الر	Subtract a plane fit from the whole image	3.1												
<u> </u>	Remove selected scan lines, replacing with interpolation	3.3												



	Apply a Gaussian low pass filter	3.4.1
alilida.	Apply a high-pass filter by subtracting a low-pass filtered image (unsharpen mask)	3.4.3
.■ . . □ .	Highlight edges in the image	3.5
Ð	Invert the height of the current image	3.6
Ż	Measure distances and angles	4.1.1
+	Measure point values	4.1.2
	Open cross-section panel for measuring heights	4.1.3
<u></u>	Open histogram window to show height distribution	4.1.4
+	Open Fourier Analysis window to show spatial frequencies	4.1.5
*	Select an area to crop and form a new image file	4.2
3D	Open 3D view window to show a 3D height projection of the current channel	4.3

1.3 JPK Force files

1.3.1 The force curve menu bar

A different set of menu options appear when a force curve window is active.

<u>File E</u>dit <u>M</u>easurement Setup <u>W</u>indow <u>H</u>elp

Pull down menu in the menu-bar	Brief explanation	Details in sec- tion:
<u>F</u> ile	File	
🔁 Open Ctrl-O	Open and load JPK files	6.1
🔚 Imp <u>o</u> rt Optical Image	Import an optical image (where available)	§ 5
🙀 Open <u>B</u> atch of Force Scans	Open a batch of force curves (batch processing)	6.5
臍 Save Force Scan	Save force scan data	6.3.1
🞬 Export as Picture	Export current channel view as a TIFF image	6.3.2
Export as Text	Export current force scan as a text-file	6.3.1
🗷 Close Frame	Close current channel window	
Exit Ctrl-Q	Close all windows and exit DP software	
Edit	Edit	
🗞 Remove Operation Ctrl-R	Remove last processing operation	6.2
<u>M</u> easurement	Measurement	
→ Calibrate vDeflection	Calibrate the cantilever	6.4.1
🔎 Smooth Force Data	Smooth the Force Data	6.4.2
↓ Subtract Baseline Offset and Tilt	Adjust the Baseline to set the zero force level	6.4.3
🐺 Find Contact Point	Find the Contact Point of the curve	6.4.4
🔤 Shift Origin	Offset the x- and y- axes manually	6.4.5
7 Tip-Sample Separation	Calculate the Tip-Sample Separation	6.4.6
💆 Chain Model Fit	Apply a Chain Model Fit	0
🜌 Elasticity Fit	Apply the Hertz Model to fit the Young's Modulus	6.4.8
🖋 Step Fit	Find and Fit Steps in the data	6.4.9
ြှင္ Curve Minimum	Measure the Minimum value from the curve	6.4.10
✓ Area under the Curve	Measure the Area under the curve	6.4.11
Nr Measure slope	Measure the Slope of the indentation part of the curve	6.6
	Find the height corresponding to the setpoint	6.4.1
∲- Filter Series	Filter in a Batch Processing Series	6.6
⁺⊊ Measure Distances	Measure the Distance between two coordinates	6.4.13
Setup	Lavout	
ASCII Export Settings	Open the ASCII Export Settings	6.3.1
Logging <u>S</u> ettings	Open the Logging Settings	1.5
<u>Window</u> Tile <u>V</u> ertically	Window	
Tile <u>H</u> orizontally	Cattings to allow tide allowers of asymptotic and windows	
Close All Frames	Settings to allow tidy alignment of currently open windows	
Auto-save Window Layout Save Window Layout Now	Start/stop the automatic saving of frame properties	
Forget Saved Window Layout	Save the current frame properties	
Quantitative Image: qi-data-2011.12.08-17.00.29.jpk-qi-da Overview	Reset the frame settings to delivered default	
	-	
	List of currently open windows	
	view relative location of scans in the image viewer	



<u>H</u> elp	
<u>A</u> bout	
<u>C</u> redits	

Help

Information about the current software version

1.4.2

1.3.2 The force curve shortcut bar

Different icons appear when a force window is active. These show shortcuts for the operations available to process or analyze the force curve. A short explanation for each icon is shown in the table below.

	txt	<	V → F	when	∕ ŧ ₩	(0,0)	7-	2	T	^۳ لس	6-	┣-	\diamondsuit	N∕⊏	` ~~=	*+

Shortcut icon	Brief explanation	Details in Section:
	Open and load JPK files	6.1
data	Save modified force curve data (JPK force file format)	6.3.1
PIC	Export current force curve view as a TIFF or other graphical format image	6.3.2
txt	Export current force curve data as a text file	6.3.1
	Open the Overview image viewer to show AFM and optical images and force curves together	s 2.2
	Remove last processing operation	6.2
$V \rightarrow F$	(Re) Calibrate the V-deflection by adjusting sensitivity and spring constant	6.4.1
when	Smooth the Force Data	6.4.2
_/ ₽	Subtract the Baseline to set the zero force level	6.4.3
	Find the Contact Point of the force curve	6.4.4

1(0,0)	Shift the Offset for the x- and y- axes to set the origin where the tip meets the surface	0
7-	Correct the height for the cantilever bending to calculate the Tip-Sample Separation	6.4.6
<u>_</u> t	Apply a Chain Model Fit to a force-distance curve (WLC and FJC)	0
	Apply an Elasticity Fit to determine the Young's Modulus (Hertz and related models)	6.4.8
*لبرل	Find and Fit Steps in the data	6.4.9
\	Measure the Minimum value from the curve	6.4.10
-	Measure the Area under the curve	6.4.11
\$ -	Perform a Filtering Series operation to filter data in respect to a chosen parameter.	6.6
N-	Measure the Slope of force curves, as in the SPM software	6.4.12
*	Find the Height corresponding to the Setpoint	6.4.1
+_+	Measure the Distance between two coordinates	6.4.13

1.4 Software versions and updates

The JPK NanoWizard[®] is delivered with the newest version of the JPK software. JPK's Software "SPM" and "DP" are written and maintained by JPK developers. If you have any suggestions for improvement of the software or if you find any bug please contact us: support@jpk.com

If you find a software bug it is helpful for us to get as much information about the circumstances as possible. If any error or warning/information message occurs the included text is automatically written to a special log file that you find in your directory \user\jpkdata\. It is helpful for our software support if you can send us the content of the log file or the whole file as an attachment. The name of the log file consists of the date and the time the software was last launched, for example "spm-2005.05.27-21.16.43.log".



1.4.1 Updating your software

To download your free software updates, please go to the following web page on the JPK Instruments website:

http://customers.jpk.com

This web page is password-protected; please enter the login name and password. The login-name is your device number, e.g. *a0016*, which you can find on the sticker on your AFM head. The password is provided with the AFM system. Note: The password required here is NOT the administrator password for your Linux computer. The software download and installation will update both the SPM and DP software versions at the same time.

If you have lost or forgotten your password, or have problems downloading or installing the upgrade, please contact us for assistance. E-mail support@jpk.com or call our technical support line on +49 30 5331 12545.

1.4.2 SPM software version

If you contact JPK for assistance concerning the software it is helpful for us to know which version of the SPM software you are using. From the main drop-down menu at the top of the window open **Help** \rightarrow **About** to get the version number.

In this example Version 4.0.13+ is used.



1.5 Logging Settings

<u>S</u>etup

Logging <u>S</u>ettings

The settings for the error logging can be adjusted via $\textbf{Setup} \rightarrow \textbf{Logging Settings}$

Logging Setting	s L 🗆 🗙
Log - File - Logger	Log monitored tasks 🛛 👻
Dialog - Logger	Log each message 🛛 👻
StatusBar - Logger	Log monitored tasks 🛛 🔻

The logging settings determine where relevant messages, errors and warnings should be displayed:

- Log-File: information written in /jpkdata/*.log
- > Dialogs: information displayed in pop-up dialogs
- Status Bar: information appearing in the lower status bar of the SPM software

Log each message Log method traces Log debugging message Log hint message Log monitored tasks Log each message Log errors and warnings Log only errors Log nothing

Each logger can be adjusted separately by setting what is to be logged. Warnings and errors can give useful information about the status of the AFM and may be a guide to the source of a problem.

Before deactivating all loggers, please keep in mind that these loggers are used to track unforeseeable errors that might occur. Especially the log files can be used for later bug fixing.



§ 2 Image files and the processing window

2.1 Opening a JPK image file



 **** Open an AFM data file

 Look jn:
 \$555
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •
 •

To open a JPK SPM file, select $\textbf{File} \rightarrow \textbf{Open}$ from the pull down File menu.

Alternatively, click on the open file icon:



The **Open** file dialog will open. The default folder that is displayed initially is the **jpkdata** folder of the user that is logged in. With each subsequent image that is opened the folder displayed within the **Open** file window will be the last folder from which an image was opened.

The JPK SPM program generates different kinds of data, such as images or force curves, however, all type of JPK data files is displayed in the open file dialog. The default setting is to display **All JPK files**. To display JPK image files within the given directory choose the **JPK Images** option at the bottom of the window. All image files will appear as a thumbnail and a filename in the form **filename.jpk**.



Move up a directory in the file tree

Jump to the home directory of the current user

Files displayed in a list



Files displayed as icons.



JPK Select channels	to process from	save-2006 🔀
Channel Error signal Height Height (measured) Lock-in phase	Trace	Retrace
		\sim
^{JPR} Select channels	to process from	save-2006 🔀
¹²⁴ Select channels Channel	to process from Trace	save-2006 🔀 Retrace
Channels Channel Error signal Height Height (measured) Lock-in phase	to process from Trace V V	save-2006 🔀 Retrace
Zelect channels Channel Error signal Height Height (measured) Lock-in phase	to process from Trace V V Select All	save-2006 🔀 Retrace

To select a file, click on the thumbnail or the filename, the selected file will then be highlighted in blue, and the name will be displayed under **Filename** at the bottom of the window.

When a file is selected the **File info** will be displayed on the right. This includes details of the scan size, resolution, imaging mode and any information saved with the SPM file by the user under **probe** or **comments**, as well as the Approach ID.

To open the selected file, click the **Open** button.

The DP program offers a dialog to select which channels should be opened. The dialog window shows the list of saved channels for the selected image. An inactive box (light grey border) corresponds to an unsaved, channel, for instance when a channel is saved in the trace but not retrace image. The channels that are now selected with the tickboxes will all be opened for processing when **Load** is clicked.

By clicking the **Select All** icon, all saved **Trace** or **Retrace** channels will be selected.

All channels that are loaded into the DP program will be opened in their own window.



2.2 The Overview image viewer

In the SPM program the image viewer shows multiple images in the correct locations. The **Overview** window in the DP software shares many properties with the image viewer in the SPM program.



The **Overview** window is already displayed before any images have been opened. As AFM or optical images, force curves and other kinds of data are opened, they will appear in the **Overview** window.

The blue square represents the 100 x 100 μ m range of the piezo, and images that are opened will be displayed with the offset of the original scan.

The **Overview** window generally functions like the image viewer in the SPM program and provides the scan comparison and combination in the offline software.



As each image is opened it will appear in its own data processing window, as well as in the **Overview** window. A thumbnail for each image appears in the right panel of the overview window, like the scan list in SPM. As the images are manipulated in the processing window, the image in the **Overview** window will also be updated.

Each image will be displayed with the original offset from the image acquisition. It only makes sense to compare images in the Overview window that have the same approach ID (and hence same lateral offset).



A single click on the thumbnail will select the image (as in SPM), so it is plotted on top of the other images. To display it at maximum size within the **Overview** window, click on the **Focus** button. **Focus All** expands the view to fit all the opened files in the **Overview** window.

The general plotting order of the images can be adjusted using the green arrows at the top of the right hand panel.



Double-clicking on the thumbnail raises the corresponding processing window to the front of the DP display, so that the image can be modified.



The **View** function works in the same manner as it does in the SPM program. When View is selected a **Scale** bar and **Angle** bar are displayed. The user can then manually adjust the scale and angle of the display.

The mouse wheel also functions as in SPM. Scroll the mouse wheel to zoom in and out from a particular location. Click and drag with the mouse wheel to shift the view within the window.



An image of the current **Overview** window display can be exported by using a right-mouse click within the window and then selecting the **Export as picture** option.

Also available in the right-mouse menu are options to change the view and also to **Measure Distance**.

All the processing of images is done on each individual image in the **Processing window**. The axis and color scale settings are also controlled by the Processing windows.

2.3 The processing window

2.3.1 Processing and Overview windows



When an image is loaded into the DP program it is displayed within a new processing window and also in the **Overview** window. In the right panel of the image viewer a thumbnail of the image will appear

An image can be selected for analysis by doubleclicking on the thumbnail, or clicking once within the processing window itself. The selected image is highlighted with a blue header bar, whereas in the other, inactive images the header bar is grey.





2.3.2 View panel



When an image window is active, the data processing and measurement functions are now available in various locations:

These can be accessed from the **pull down menus** at the top of the screen.

Alternatively, the most commonly used functions can be accessed via the short-cut **icon bar**, with data processing functions to the left and measurement to the right.

The common functions used for measurement can be opened using the **right mouse button** menu.

The default display in the right hand side of the processing window is the **View** panel. Here are the settings for displaying the image.

The tick box **Show axis** adds the xy axis display to the image.

The **Show color scale** tickbox displays the color scale in the image view. The range of the colorscale is displayed as text in the **View** panel. The colorscale can be adjusted to highlight the features of interest, see **Section 2.4** for more details.



The **Relative color scale** tickbox displays the numerical values for the height range with the lowest value set to zero.

The absolute values are still shown in the panel above the tickboxes, but the displayed image now shows a relative range. This format is usually used for exporting images for presentations, since the absolute piezo position is not usually relevant information.

The currently set axis and color scale settings have no effect on the saved data, but they are used for the image export, see **Section 2.5.2**.

2.3.3 Info panel

👁 View 🕥 Info		^	
Channel:	Height		
	Trace		
Name:	no name entry		
Account:	kate		
Comment:	no comment entry		
Probe:	no probe entry		
Line Rate:	1.000 Hz		
Overscan:	0.053 s		
Size:	100.0 x 100.0 µm		
Offset:	-0.0, 0.0 µm		
Pixels:	512 x 512		
Date:	Apr 21, 2006		
Time:	12:04:01 PM		
Mode:	Contact mode		
IGain:	480.0 Hz		
PGain:	0.0360		
Setpoint:	-190 mV		
Baseline:	0.0 V	۲	
Approach ID:	0.57.00019	-	
4	××××××××××××××××××××××××××××××××××××××		

The other panel that is always available on the right hand side of the data processing window is the **Info** panel. This contains information about the saved scan, e.g. scan parameters and the time and date of image acquisition, as well as the account within which the scan was saved.

Any comments entered by the user when the scan was saved in the SPM program are also displayed here.

The Approach ID is a reference number that is updated every time a stepper motor approach is made. Therefore the coordinates from different files with the same Approach ID should be the same. This information can be used to link different images where the coordinates have not been reset by moving to a different area.

2.3.4 History bar and remove operation



In the data processing window, there is a history bar across the top of the window. This shows the list of operations that has been applied to the image. Previous processing steps can be viewed or changed by clicking on the icons in the history bar.



Individual operations can be removed from the list using **Remove operation**. This can be selected from the icon bar or by using the right mouse button in the history bar and selecting **Remove operation**.





2.4 Colortables

2.4.1 Choice of colortables



Image data can be displayed in one many different color tables. The color table can be changed for the selected image by choosing the pull-down menu under **Colortable**, or the default for a certain DP session can be changed by selecting **Default Colortable**. The colortables are also available from the right-click menu in any data processing window when the mouse is over the image panel. The currently selected colortable is indicated in the list.



Darkgold is the default colorscale for both SPM and DP. This is a relatively simple colorscale, with one main color gradient from dark brown through gold to white. This is relatively flexible, but for many cases a different colorscale will be chosen. Often this is a matter of personal preference – the **Default Colortable** option allows a new default selection for the current DP or SPM session. Currently open images are not affected, but newly opened images are shown in the new default colors.

There are also some general rules that can enhance visualization of different types of samples, depending on the data range of the image. Here are a few general suggestions for finding a good choice of colortable.

Images with many small features through a much larger overall height range





Samples such as cells contain small structures against the background of the large height differences due to the cell body. With a default colortables these features are difficult to visualize – a colortable is required with many different color changes to highlight small features over the whole range.

In such a case the **High-structures 1** color table shown here can highlight more detailed surface structure. There are several **High Structures** colors-cales which all have multiple bands of color, so contrast can be seen on many different levels in the image.

For images where higher contrast is required than Darkgold, for instance, but the structures are not as tall as cells, there are a number of three-color color tables. **Peacock** is shown here, these colorscales can highlight smaller features against a background. In this case smaller structures on top of the spheres are more apparent than if a single-color color scale is used. With a clear double color change, small features are highlighted, without being so confusing as colortables with many color changes. **Rainforest** is another useful mid-range colortable, with dark blue, green and yellow.

Images with distinct features against an uninteresting background



Fine detail within samples with small height differences can often best be visualized if a color table based on a dark background color is used, such as this **Darkbrown** color table. The low contrast in the lower end of the scale gives a subdued background, so that the bright highest features are seen sharply.

The apparent resolution can also be affected by the colortable – changing from Darkgold to Darkbrown for an image such as this one will increase the apparent resolution, although the image data is of course completely unaffected.

Screen color versus print color, 2D view versus 3D view



Remember that the colors displayed on screen are different from the colors that will be printed. The conversion from RGB (screen) to CMYK (most printers) is difficult for many colors, particularly light greens for instance. Sometimes it may be better to make the conversion in a graphics package after image export, and adjust the overall color range if necessary.



The colors also appear different in the 2D and 3D views. The shadows in 3D enhance the contrast, where for some colortables the image in 2D view had too little contrast. Often a color range with light colors shows up the shadowing in 3D view best, although it may seem low in contrast in the normal 2D processing window (compare 2D and 3D views of this image, which are shown for the same settings and colortable).



2.4.2 Statistics, MinMax and Fixed Range colorizers



 Statistics 			
🔿 MinMax			
🔵 Fixed Range			
Offset		0.900	
-2.000		2	2.000
Multiplier		2.200	
0.000		10	0.000
		R	eset
Maximum of col	or scale	466.	5 nm
Minimum of cold	or scale	382.1	1 nm
Image maximur	n	451.3	7 nm
lmage minimun	n	358.	7 nm



In the **View** panel are the settings for how the image data (height, deflection, phase etc) is converted into the different colors. The JPK software generally uses a conversion based on the statistics of the image data range. This allows the software to automatically choose suitable settings for images over any range, regardless whether the height range is nanometers or microns. The color settings also adjust automatically during processing when the height range of an image is changed, for instance during **Linefit**. This is designed so that for most images the settings do not need adjusting during data processing.

When an image is ready for export, these settings may need adjusting – e.g. to set a particular height range for comparing different images. There are three different conversion functions available in DP; **Statistics**, **Min/Max** and **Fixed Range**. **Statistics** and **Min/Max** are the same as in SPM. **Fixed Range** is only available in DP.

The numbers show the overall maximum and minimum data values in the image, and the max and min versions used in the color scale for comparison.

Statistics

Sigma is the full width at half maximum of the data range distribution over the whole image, and is the reference for the settings. **Offset** and **Multiplier** are dimensionless numbers in terms of sigma.



Multiplier is the factor that is applied to scale the width σ of the color scale.

Offset shifts the centre position of the color table relative to the data range.

MinMax

The minimum and maximum values of the color range can also be set as a percentage of the minimum and maximum data values.

For images with a few outlying points that are far above the main data range, the Statistics conversion will tend to ignore these particular points (which is good if they are just due to noise, or the cantilever sticking briefly to the surface). **Min-Max** can be used to scale the color table over the whole data set, regardless if most of the points fall in a much narrower range. Note the numbers in the panel showing the color range and data range.

🔾 Statistics			
🔾 MinMax			
Fixed Range			
Offset		382.1	nm
Range		84.4	nm
			Reset
Maximum of col	or scale		466.5 nm
Maximum of col Minimum of colo	or scale or scale	:	466.5 nm 382.1 nm
Maximum of colo Minimum of colo Image maximur	or scale or scale m	:	466.5 nm 382.1 nm 451.7 nm
Maximum of col Minimum of colo Image maximur Image minimun	or scale or scale n n	:	466.5 nm 382.1 nm 451.7 nm 358.7 nm

Fixed Range

This is rather different to the other colorizer settings, because the numbers here are defined in fixed units (the same as the image data), rather than being dimensionless quantities. This allows the user to set, for example, a defined height range of 10 nm for several different images, or change the height range to make it a "round" number.

The offset can be used to move the fixed range through the image data, to make the whole image darker or lighter. Here, for instance the Range with the default settings is 184.5 nm. This could then be set to 200 nm, for example, and the Offset adjusted to take account of the slight color shift.

Changing between different colorizer settings

Since the **Statistics** colorizer does the best job of choosing a reasonable height range for general images, the **Reset** button sets the image back to the default **Statistics** colorizer settings, regardless of which colorizer is being used at the time. Hence **Reset** will produce different values of **MinMax** for example, depending on the image data.

2.4.3 Adjusting the colorizer settings



6 Histogram (nm) The **Statistics** colorizer bases the color conversion on the average value and the width of the height distribution. This automatically gives reasonable settings for many images.

The **Statistics** settings are not always optimal when most of the image is a flat background, as shown here. The **Histogram** tool (see **Section 4.1.4**) is useful for checking color settings. The linear histogram display here shows that most of the points are in the background, with a range of around 1 nm. Only a very few points are at the top end of the height range, around 12 nm.

Using the logarithmic **Histogram** display shows the full range of height values – here the low, broad peak of the higher objects is also visible. In the colorscale below the histogram there is no color contrast for the highest features (above 4 nm), they are all white.





Here the settings have been adjusted to give contrast over the whole range. The **Multiplier** has been **increased** to give a broader distribution, and the **Offset** has been **increased** to bring the centre of the distribution towards higher features.

Note that for this case, **Offset** has been set to 5.0, outside the range of the slider. Any number can be typed in the text field, the slider just gives the most commonly used range in a convenient form.

The color in the image now shows contrast over the whole range of the higher features.

2.5 Saving data and exporting images

After processing an image there are two options for saving. The image data can be saved such that it can be reloaded into the DP program or an image file in TIFF format can be exported.

The easiest way of saving data as a processed file or as a graphics image is using the right-mouse click window in the image panel. This can also be used for saving image exports of analysis functions such as the **Histogram** or **Section** tools.

2.5.1 Save data

As the DP program only reads the JPK file format, any images that are to be processed further should be saved in this file format. If the image has been processed then the altered version of the image, not the raw data, is saved. Only the single channel in the processing window is saved, as a separate file from the original data, so the original data is usually not overwritten.

2.5.2 Export image



JPK

To be able to open the image in other programs for the production of reports or presentations, files can be exported in TIFF or another graphics format. The image, exactly as it is displayed in the processing window, is exported as an 8-bit TIFF file. The current DP settings for axes, color scales etc are all used for the TIFF export. If a Section line is drawn in the image, this will also be exported, but boxes drawn for processing operations will not be shown (for instance during the leveling process).

iave <u>I</u> n: 🗀	New Folder	- 🔁 🖻 📽 🗄
		Decoration Include filename Include channel name Transparent background Use a larger font Tmage Size Original size (512x512 pixels) Scaled to Size
ile <u>N</u> ame:	save-2006.11.02-14.34.10_height_trace.tif	
iles of Type:	TIFF image (uncompressed)	

Standard export (axes and colortable enabled in View panel):



File and channel names included.

Filename: save-2005.09.26-17.09.53_height_trace.jpk Channel: Height; trace



The **Export as Picture** dialog allows many different export options for the graphical image – the file format and content can be modified using the options in this dialog.

The filename and channel name can be added as text to the top of the exported image using the tickboxes here.

A transparent background can be selected. This background may appear black in certain preview programs that do not support transparent format, but in PowerPoint presentations, for instance, this will remove the solid rectangle normally surrounding the image.

The file format can be TIFF, PNG, JPG or BMP. The option "Use a larger font" increases the font size in the exported image if axes or colortable values are included in the image.

The Image Size options are particularly useful for exporting images with a very small number of pixels, as for instance for mapping images or cropped parts of images. This rescales the output to a fixed number of pixels. This can also be used for presentations or reports where images have different pixel numbers, for instance if 512 and 256 pixel images are to be displayed together.



Larger font, no extra text.



Map image with 128 pixels, exported using the standard Same map image exported scaled to 512 pixels. options.







fast [µm]

§ 3 Data processing operations

The DP program offers a number of ways to process images. The first step in processing an image would usually be to adjust the z-data such that the structures of interest are visible. This is necessary when interesting features lie within a limited data range that is obscured by a variation or tilt in the background. In contrast to the rescaling in the **View** panel described above (see **Section 2.3.2**), the operations described in this section actually modify the image data. There are two basic approaches for modifying the z- (height) data:



The plane fitting function is designed to remove background information that arises from an overall sample tilt. In this case a user-defined plane is subtracted from the image as a whole, so that the relationship between adjacent scan lines is kept.



Alternatively, correction for an offset in the height data can be corrected line by line. In this case, the scan lines are fitted with a user-defined polynomial and the fit is then subtracted. The fit and subtraction is calculated for each scan line independently.

3.1 Plane fit



Any tilt of the sample support during imaging will be seen in the height or height measured channels. The Plane fit operation fits a plane (linear or curved) to the selected sample regions and subtracts this from the measured data.



In this example, most of the image shows the edge of a cell. On the left, the glass substrate can be seen, but this shows a color gradient because it is not level compared to the scanner. This must be leveled so that the height of the cell edge can be accurately measured.

The first-order (linear) option is good for removing the tilt angle from the sample mounting. The advantage of the **Plane fit** function compared to **Line fit** is that information about the offset between scan lines is not lost. The plane is only fitted to the selected regions, but the fitted plane is then subtracted from the whole image. So there are no line-to-line offsets.





+ Height (measured) : trace (tip-QDglass-2007.06.22-13.36.18 heightMeasured_trace-tilt.jpk) ■ X (0.004 μm) (0.

* Height (measured) : trace (sample-2007.06.22-10.24.22.jpk) P 👁 View 🕕 Info Customize the view. Adjust the color table and configure additional elements of the view. Statistics MinMax Fixed Range Offset • 0.900 🔺 -.... -2.000 2.000 2.896 🔺 Multiplier • 0 0.000 10.000 Reset Maximum of color scale 9.322 µm Minimum of color scale 8.082 µm Image maximum 9.308 µm mage minimum 8.25 µm Show axes Show color scale Relative color scale

Here, **Degree** = 1 is selected, meaning that a simple (linear) plane fit is used. The selected region can be seen as the red box on the left hand side. It is best to select all the area where the background can be seen, to get the best average and offset on the plane.

Multiple regions can be selected in the image area, and the rectangles can also be resized and shifted. The **Clear** button removes all the selected regions from the list.

If the tilt is large and the features are small, as in this example, then the sample structures cannot be easily distinguished. One option is to select the whole image area with a large rectangle selection box.

It is also possible to select three "points", as in the old version of this feature. By clicking once in the image, a 1x1 pixel region is selected, and this can be repeated to add more points. Note that if only three points are used, they should be widely spaced, and not in a straight line. A large triangle, spread over the whole image region, is the best arrangement.

The plane fit operation can also fit higher order polynomials. This can be useful to remove a curved background, for instance here where the image is of the nuclear region of a cell. The cell covers the whole image region, and the image is dominated by the bright nucleus.

In this case, the motivation is to remove the largescale curvature of the cell surface in order to visualize the small features better. The plane fit is therefore used as a form of high-pass filter. If used carefully, this can sometimes keep the relative height of small features by subtracting the overall background curvature.



For this example, Degree = 9 is chosen, to remove as much curvature as possible. The whole image region is selected so that the fit covers the whole image. The small protrusions on the cell surface can now be seen much more clearly.

3.2 Line fit

In contrast to the plane fit operation, line fitting corrects for offset within the image line by line. Each scan line can be fitted with a chosen model, for instance with a simple offset (degree 0), straight line (degree 1) or higher polynomials. The calculated fit for each line is then subtracted from the same line independently. It is important to keep in mind that information about the measured offset between scan lines is lost. However, the line fitting operations are best for adjusting images when the structures are small in height and the offset between lines can be significant.

3.2.1 Linefit



Each scan line is fitted with a linear or polynomial fit, which is then subtracted from the data. The aim is generally to correct for the "background" height changes and exclude the areas of the image containing particularly high or low features. This allows the height of these features to be measured afterwards.



Here is a case where a line fit needs to be used. The raw data has already been treated with a plane fit, however, as the structures at the surface are only a couple of nanometers in height the offset between each line is noticeable.

As soon as the **Linefit** icon is clicked, the fit will be made and subtracted from each line.







14.6 🔺 286.0 ▲ Y1 Х2 ▼ 495.7 4 . 286.0 ~ Minimum in Z-Range not selected Maximum in Z-Range not selected Length of Line: not selected 🗹 Show length on line

The operation removes the offsets between adjacent scan lines, so flat areas of background now look smooth. However, there are characteristic shadows around high features in the image.

This is because the fit is to the whole scan line, not just the "background" areas that should be made flat. Where high features are included, the average for the whole line is shifted down to compensate, leaving the characteristic striped shadows.

The areas with high features in the scan lines should be excluded from the line fit.

Select regions by using click and drag in the image display area. The selected boxes will be shown in the image and details about the excluded areas appear in the right hand panel of the image window. In this case there are many features on the surface, so the image should rather be fitted with the **Histfit** feature, see **Section 3.2.2**.

The active box is shown outlined in red, the others are outlined in black. Clicking on an entry in the list of areas will activate that box. Active boxes may be shifted, or the boundaries moved with the mouse. The **Clear** button clears all the marked areas from the list.

The **Linefit** function allows a polynomial of degree up to 9 to be fitted to each line and subtracted.

The selection of which order polynomial to use will depend on the background curvature. In this example a **Plane fit** has already been used to remove the overall tilt. However, as the structures on the surface are in the nanometer range the offset between scan lines is clearly visible. A cross section taken along a scan line also shows the curvature of the background surface. The more curved the background the higher the fit that is required.

Height (nm)



Here a second order polynomial (**Degree** = 2) has been used. However, the background is still curved, showing that the fit order is not high enough.

Note that the options in **Linefit** are the same as the "Leveling" display options in the SPM software. The degree, of the polynomial used to fit the individual scan lines can also be chosen there, although the labeling is constant, linear, quadratic etc rather than degree = 0, 1, 2 etc. In SPM the operations are just used to display the image, but the raw data is always saved. Here the modified data can be saved as a new file, or the image exported for use in graphics or presentation software.

To generate an image with a completely flat background, here the **Degree = 9** was set and each high feature excluded from the line fit by clicking and dragging a box over each region of interest. The areas excluded from the fit are displayed in the right hand panel. The cross section tool shows that the background surface now appears flat.

3.2.2 Histfit



Height (nm)

The **Histfit** operation is an extension of **Linefit**, designed to make the selection between "background" and "features" easier and more convenient. A histogram is used to define a certain range of pixels, along each line, that should be excluded from the fit. This enables background and features to be distinguished without drawing exclusion areas. A histogram is made of each scan line individually, and only the range of pixels between **Lower limit** and **Upper limit** are used to make the fit.



The default settings are **Lower limit** = 0 %, and **Upper limit** = 70 %, so only the pixels in the range 0 - 70 % of the histogram for each line are used for the fit.

Note that If there is a sample tilt then a plane fit may be useful first, so that in each scan line the higher and lower pixels correspond to the features and background, not just the sample tilt.

Clear





The right hand panel allows selection of the polynomial **Degree** to be used for the fitting and also the range of pixels to be included in the fit.

Here, the **Lower limit** is 5 %, and the **Upper limit** is 90 %, so the lower 5% and upper 10 % of pixels for each line are excluded from the fit. The pixels of the high features are now automatically excluded, so the same results as in the **Linefit** example above are achieved without needing to draw boxes around the features. Additional areas can also be excluded manually from the fit function if needed.

3.3 Remove Lines



The operation **Remove lines** can be used to replace a scan line with the average between the neighboring scan lines. This is useful if there are some scan lines where the tip sticks and then pulls off, leaving streaks in the image.



On sticky samples, the tip can become stuck at some point on the same, causing a streak in the image as the piezo pulls the tip free from the surface.

When the operation is open, the cursor will change to show a symbol for erasing lines. Click on the image to mark the lines for removal.


Multiple lines can be marked. Lines listed in the table on the control panel can be selected by clicking on the relevant table entry. Once a line is selected it is highlighted in red and the table entry can be changed manually. Lines can also be moved around the image using the mouse.

Delete removes the selected line from the list. Clear removes all marked lines from the list and New allows a new line number to be typed directly in the list.

The data in the lines is replaced as soon as they are selected. The black marking of the lines can be switched on and off with the tickbox "Mark Removed Lines". With the marking removed, the image can be seen as it will appear for export or further operations.

3.4 Low and Highpass Filters

Sometimes it is helpful to modify the data across the whole image, rather than changing individually selected scan lines. The filtering operations change the balance in the image between the smaller features and the larger features. For images where noise is a problem, then selectively removing small features (using Lowpass or Median filter) can make the background topography clearer. For images where the interesting features are small, and not so easy to see against large background topography changes, then a Highpass filter can selectively highlight the small features.

Clear

Mark Removed Lines

New

3.4.1 Lowpass

ılılılı. • → × The **Lowpass** operation convolves the image with a Gaussian kernel; the width of the Gaussian is specified as a number of pixels.



* Height : trace (save-2006.10.27-14.36.32.jpk)

- 式 🖬



d" 🗹 🗵

F(2) 🖉 View 🕅 Info

)earee of

Sigma >

0.100 px

onvolve the image with a Gaussian kernel

0.900 🔺 px

10.000 p>

Here is an example of a height image where noise can be seen.

This is clearer in the right hand image, where the same information is displayed with the "High structures 1" color table, which shows up the smaller features.

The smoothing here is with a Gaussian of width 0.9 pixels, and the noise has basically been smoothed without affecting the underlying topography.

In this case the scan was taken with 1024×1024 pixels, so even with after applying a low pass filter there will still be more information than in an image with 512 x 512 pixels.



In this case the image has probably been oversmoothed; the Gaussian of width 3.4 pixels is probably too much for this particular image.

The optimal value will depend on the size of the noise or features to be removed. Since a 3D view of the height generally enhances the small features, sometimes a little more smoothing is required for 3D projections than for the standard height view.



The image filtered with a 0.9 pixel Gaussian, back in the original color table.

3.4.2 Median filter



The action of the Median filter is similar to the Lowpass filter. It works in this case by replacing pixels with the median value of neighboring pixels.



The **Mask shape** controls the arrangement of neighboring pixels that are considered, and the **Mask size** controls how many pixels in this shape are considered.

This image is the same as the example used for the Gaussian Lowpass example. This time a Median filter (square, 7 pixels) has been applied.

The Median filtered image returned to the original color table.





3.4.3 Highpass



A high-pass filter enhances information with a higher spatial frequency. This is in a general sense equivalent to subtracting the background (low spatial frequency) curvature from an image to better show the small features on the surface.

ď 🛛 🗆

Height

Error signal



In this pair of height (left) and error signal (right) images, many of the smaller surface features, such as the pitting, are only visible in the error signal image. In the height image, the information is there, but hidden by the curvature of the cell.

* Height : trace (save-2005.06.19-15.12.26.jpk)



e (save-2005.06.19-15.12.26.jpk) ь^к 🖉 🗵 📑 F(2) ` 👁 View \ 🚯 Info ` Customize the view. Adjust the color table and configure additional elements of the Statistic MinMax Fixed Range 0.783 🔺 \odot 2.000 Multiplier -2.829 🔺 0.000 10.00 Reset Maximum of color scale 6.225 µm Minimum of color scale 5.453 µm Image maximum 7.256 µm Image minimum 5.029 µm Show axes Show color scale Relative color scale

The highpass filter is applied by subtracting a lowpass filtered version of the image, and then adding this highpass filtered image to the original with a scaling factor (this procedure is known as unsharpen mask).

The low-pass filtered image represents the background curvature on the surface, and the difference between this and the original image shows the small details on the surface.

The top part of the panel gives a scale factor for the low-pass filtered image, and the lower panel gives the degree of smoothing of the low-pass image (this is as for the **Lowpass** Gaussian – see **Section 3.4.1**).

Here both the scale factor and the degree of smoothing have been set quite high.

The **Scale** affects how large the change is to the image. The **Degree of smoothing** affects the lengthrange over which the smoothed and original images are different. Compare this image and the one directly above with the original image – the differences from the original image are greater here (larger **Scale**), and the length-scale of the differences is also larger (the smallest lines are not so highlighted, but median-sized high and low regions are clearer). Note that after the Highpass filter, the displayed height of small features is no longer reliable – for large values of Scale, the height is artificially enhanced. This feature can be used to highlight the distribution of small features, but the data should not be used for measuring small height differences after this operation.

3.5 Edge detect



This function highlights edges in the image. Below are shown the original height image (left) and the edgeenhanced image (right), with edge enhancement in both directions (default).







The edge detection can also be chosen for either the x- or y- direction independently.

With the setting to y-direction only, the scan lines can become more prominent.

With the setting to x-direction only, the height image becomes very similar to the normal error image; both are related to the gradient of the height information along the fast scan direction.



Error signal image





3.6 Invert image



This operation inverts the data in the image. An example is shown below where a standard height image is inverted. The height information is also shown as a line section (see **Section 4.1.3** for more details). The image is shown inverted in terms of the color scale, and the line section shows that the height information is converted to negative values.



Other image tools **§**4

4.1 Image analysis tools

In addition to the operations that are available for modifying the information in scanned images, there are also some tools available for measurement and analysis. These tools do not modify the information saved in the channel, but they can be used to extract numbers from the images.

These tools open another tab panel in the control panel side of the image window. Some tools, such as Section, Histogram and FFT also open another panel in the image side of the window to display the data graphically. These functions provide data that can either be saved as an ASCII file with the numbers in, or a view of the graphical panel can be exported in TIFF format. Measure and Points just provide quick measurement of values, without data export.

4.1.1 Measure



The Measure tool allows the measurement of distances and angles from images, as in this example of collagen microfibrils



Large-area orientation of repeating units, can also be analyzed using the FFT tool (see Section 4.1.5).

The first click sets the corner point for the angle measurement (the upper point here). The second click sets the fixed arm for the measurement (the lower point here).

The **Distance** is measured between these first two points.

The third click sets the moveable angle arm for the measurement (left hand point here). The Angle is measured between the two arms. Further clicks in the image panel reset the third point, so different angles can be measured. To reset all the points, click Clear in the control panel Measurement tab.



4.1.2 Points



The **Points** tool can be used to measure the channel value at a point. In this case, the image is height, so the height information is read out at the position where the points cursor is set.



The coordinates are given in pixels (I,j), and as lengths – within the image, and relative to the overall (x,y) coordinates of the scan piezo.

4.1.3 Section





The **Section** tool opens a cross-section panel for measuring the range of image values along a line.



The line is set by clicking and dragging in the image panel. The coordinates can also be entered or adjusted by hand, so the same sections can be made through several images.

The range of values along the line is given in the **Cross section** control panel tab. The length of the line can be shown in the image using **Show length** on line.

Images exported from the main image panel will show the section line, and also the length value if selected. The cross-section is updated dynamically as operations are applied to the image.

If the mouse is used to click and drag in the crosssection panel rather than the image panel, then markers are shown on the line section. The **point-topoint measurement** is also shown in the control panel. This can be used to measure the separation or height difference between features. In this case the periodicity of the collagen fibrils is measured as 67 nm.



Using the mouse to right-click in the cross-section panel shows a menu for exporting the cross-section information. **Save data** exports the ASCII values as a file. **Save image** exports a TIFF image of the current cross-section view. This menu can also be used to change the view to other analysis tools, such as **Histogram** or **FFT** (Fourier Analysis).

4.1.4 Histogram



The **Histogram** tool plots a histogram of the channel values.



Here, for instance, the large peak around 0 nm height value is due to the glass background, where all the heights are within a narrow range. There are two broad peaks, one around 50 nm and a second around 150 nm, corresponding to the nuclear debris and the chromosomes, respectively.

(Note – the color scale is also shown on the histogram panel, this can help with setting the **View** parameters, see **Section 2.3.2**)

When a region is selected in the image panel, the histogram is only calculated using the pixels in the selected area. In the left hand screenclip, an area of the mica is selected, and the histogram shows only values around 0 nm. In the right hand screenclip, an area corresponding to chromosomes sitting on nuclear debris has been selected, and the two broader peaks are now clearly distinguished.







5.000 x 5.000 µm

512 x 512 pixels

-5.575 nm

Physical size:

Size in pixels:

Average value:

RMS deviation: 7.213 nm Current position: The height can be measured by clicking in the histogram panel and the value is shown in the control panel.

Sometimes a high number of pixels from one height level obscures smaller peaks. This may be the case with objects against a flat background, or as here where some lipid layers show more area than others.

In these cases, displaying the log of the frequency values as shown here allows the smaller peaks to be better distinguished.



-10 Histogram (nm)

Histograms can be saved using the right mouse button menu – either as ASCII data or as a TIFF image.

4.1.5 FFT

Od/Fragmenty)



The **FFT** tool opens the **Fourier Analysis** panel, which shows the image information as spatial frequencies (i.e. 1/length). The center of the FFT panel corresponds to the smallest spatial frequencies (largest distances measured in the image). The edges of the FFT panel correspond to the largest spatial frequencies (smallest distances in the image).



The display options for the FFT panel are shown at the bottom, these require careful setting, since the range of values is so high.



The right-click menu shows various options for the view, including an option to change the colortable (for the FFT panel only, this does not affect the real-space image display). The FFT view can also be exported as a TIFF file using **Export Image**.

4.2 Crop



The **Crop** tool can be used to select an area to form a new image file. In the example below, one group of micelles is selected on the left hand side, and the cropped image is shown on the right hand side. The new image has the same number of pixels as were selected from the original image, and can be rectangular or square. The coordinates in the Crop panel can be used to set specific regions for cropping, for example to crop the same region from several different images.



4.3 3D View



In addition to the normal view of the images shown in the processing windows, as here, the information can also be displayed as a projection of the 3D information. The 3D icon opens the 3D view window.







The **Data** panel in 3D view can be used to select a reduced range of data to show in the projection, or to change the range of the color scale.

Generally the smaller surface features are highlighted by viewing the 3D height projections, so often different color scales or height ranges need to be used to give better results in 3D. The colortable is taken from the image when 3D is opened, so to change the colortable, close 3D view, change the image colortable and re-open the 3D window.



The **Projection** panel in 3D view can be used to set the viewing angles, as well as the scale factor applied to the z-axis.

In this example, the **Height of z axis** has been increased compared with the previous view.

The image can be rotated using the sliders here in the Rotate View section. Clicking and dragging in the image panel with the mouse allows the view to be changed freehand.



If the control key is held down during the mouse movement (Ctrl-click and drag), then the projected image is shifted around relative to the view window.

The whole view window can be resized to change the proportions of the view for exporting images.



If the shift key is held down during the mouse movement (shift-click and drag), then the projected image is zoomed in or out, changing the way it fills the 3D view window.

The tickbox **Coordinates** in the Projection panel can be used to switch on or off the axis display on the image. **Box** adds a rectangular box outline showing the data range (without any numbers).

TIFF images can be exported by using the right-click menu and choosing **Export as picture**.



When the image is finally exported, then the whole region within the left hand panel here is exported as a TIFF. The black surrounding region is converted to a white background, and the spacing around the projected image is maintained. If the image is zoomed to show only part of the data, then only this part is exported.



§ 5 Direct Overlay

For those systems that have the **Direct Overlay** feature installed in SPM, calibrated optical images can be imported into the DP software. The calibration must always have been made in SPM during measurement, as this is the conversion from camera pixels to AFM coordinates. Any image file can be opened, so long as it has the same geometric relationship as the calibration file. The illumination (phase contrast, fluorescence etc) and image format (jpg, png, tiff etc.) are not important.

5.1.1 Opening Optical images



To open a JPK SPM file, select **File > Import Optical Image** from the pull down **File** menu. Alternatively, click on the blue open file icon.



A dialog will open in which the **Calibration file** and **Image file** are chosen. Multiple Image files can be opened with the same Calibration file, so long as they have the same geometrical relationship between camera and AFM positions.

The optical image will appear in its own individual window (similar to the processing window for AFM image scans) as well as in the **Overview** window.

There are no processing operations for the optical images, as the DP program is specialized for AFM images. The optical images can be modified beforehand in other suitable software. All processing operations that change color, intensity, etc. are completely compatible with the optical calibration and will not cause any problems. Processing that changes the image geometry (cropping, scaling etc.) should not be applied, as this will invalidate the calibration.





In the right hand panel under **View**, the user can chose to show or hide the axes around the optical image.

The axes will appear in both the individual window and the **Overview** window.

Also in the right hand panel, by selecting the **Calibration** tab, the user can exchange the calibration or the image file.

5.1.2 Shift Optical Image



The initial selection of the tip position during the optical calibration procedure may be slightly incorrect, resulting in a shift between the optical and AFM image. This correction shift is usually made in SPM, but it is also possible in the DP software.

First select the optical image in the scan list to the right of the **Overview** window so that it is plotted on top of all images. Then click the right mouse button within the **Overview** image view and select **Shift Optical Image**.

As soon as **Shift Optical Image** is selected, the optical image is shown semitransparent and can now be shifted using click and drag with the mouse.

The image should be shifted so that the AFM and optical images are aligned. To go back to the normal view, click the right mouse button and select **Shift Optical Image** again, or just click on another image in the scan list.





Only the calibration of the selected optical image is modified. Once it has been changed, it can be saved from the individual optical image window.

5.1.3 Optical image export



The optical image can be exported in calibrated form for processing in an external program.

When exporting the optical image, the user can set the pixel number and the region that is exported (with respect to the AFM offset). This allows the user to export a specific region of the optical image to match individual regions scanned with AFM.

The size, pixel number and offsets can be read from the **Info** panel of the desired AFM image and entered into the **Export size** and **Area to export** fields in the **Export Optical Image** panel.

§ 6 Force curve files, processing and analysis

6.1 Opening a JPK force curve file





To open a force curve file, select **File > Open** from the pull down **File** menu. Alternatively, click on the **Open** file icon.



All type of JPK data files is displayed in the open file dialog. The default setting is to display **All JPK files**. To display JPK force files files within the given directory choose the **JPK force curves** option at the bottom of the window. All force files will appear as a thumbnail and a filename in the form **filename.jpk-force**.

When a filename is selected, a preview of the curve is shown in the **Curves** panel on the right hand side. In the **Info** panel, other data about the force curve is displayed, such as times, dates, settings, and a channel list. Multiple curves in the list can be selected using control-click or shift-click and opened together.

The preview always shows the first saved channel (generally the feedback channel – either vertical deflection or amplitude). All other channels are available after the file is opened, and all channels are opened in the same processing window.



6.2 The force curve window

The force curve is shown with the curve plotted in the main panel of the window on the left, and the display and function options in a panel on the right hand side.

The history works the in the same way as for image files, so processing operations can be viewed, modified or removed (see **Section 2.3.4**)

Additionally, a thumbnail of each force curve will be shown in the **Overview** window and the forcespectroscopy point is plotted with the x, y position and index number.





The common functions used for display settings, saving and measurement can be opened using the **right mouse button menu**.

In the data processing window, there is a history bar across the top of the window. This shows the list of operations that has been applied to the image. Previous processing steps can be viewed or changed by clicking on the icons in the **history bar**.



Individual operations can be removed from the list using **Remove operation**. This can be selected from the icon bar or by using the right mouse button in the history bar and selecting **Remove operation**.



6.2.1 View

Q	Ð	1				
👁 View	· ()) Info				
Horizon	tal ax	dis				
Х Мах	-	9.0 🔺 µm				
X Min		4.5 🔺 µm				
X Axis	Height (meas. smth.) 🔹					
Vertical	axis					
Ch 1	Ch 2	Ch 3 Ch 4				
Signal		Vertical deflection 👻				
Display		All 👻				
Ү Мах		▼ 3 ▲ V				
Y Min		-4 ▲ ∨				
Color (e	xtend) red 👻				
Color (re	etract) red-dark 🗸				

The **View** panel, along with the standard oscilloscope toolbar above it, can be used for setting the force curve data display options, such as axes.

The **Horizontal axis** and **Vertical axis** areas of the panel function in the same way as for the force scan oscilloscope in the SPM program. All the channels saved in the original force curve are available.

The **Horizontal Axis** can display the height channels (height (measured & smoothened), height (measured) and height) or the time (see screenshot below).

Using the channel tabs in the **Vertical axis** section all recorded channels can be switched on or off as well as the single curve segments (extend or retract). The colors for display can also be changed here – for each channel and for extend and retract separately.



The **X** Axis either can display one of the height channels or the **Time** channel. Displaying the time channel, the delay times or force clamp steps can be visualized.

In the **Display** menu all segments can now be selected to be displayed, either separately (extend, extend pause...) or **All** together (default).

Most processing operations use the force-distance display rather than the force-time display.

6.2.2 Display toolbar and zooming



Q

The standard oscilloscope toolbar contains various shortcuts for displaying the force curves. The arrow buttons reset the axes to the full data range in the force curve. The options are for both X and Y (both arrows), Full Range X and Full Range Y.

The **Zoom** tool allows a rectangular zoom region to be set in the plot area. Activate this mouse feature, then click and drag in the plot area to set the zoom region. The display will automatically update to the new ranges.



It is also possible to adjust the display ranges using the mouse wheel. The wheel can be rotated to zoom into or out of the curve by changing the x axis. The curve can be shifted by clicking and dragging with the mouse wheel. Once the correct region of the curve is selected, a **Full range Y** can be activated to scale the y axis for the new region.

If the right mouse button is clicked inside the plot area, the menu provides additional options for rescaling the display and adding analysis features as well as several saving options.



•

6.2.3 Info

👁 View 🕕 Info					
Name:	no name entry				
Account:	rachel				
Comment:	no comment entry				
Probe:	no probe entry				
Segment	Extend				
Channels:	Vertical deflection Time Height (measured) Height				
Date:	1/8/09 6:26 PM				
Feedback Mode:	Contact mode				
Force Settings:	relative				
Z Length:	0.5 μm				
Z Scan End:	0.0 μm				
Setpoint:	400.0 mV				
Baseline status:	off				
Baseline value:	-0.000 V				
Exp. Pixel Num:	1024				
Pixel Num:	1024				
Data Rate:	2048.000 Hz				
Speed:	1.0 µm/s				
Duration:	0.500 s				
Position Index:	0				
Position:	X: -490.41 nm				
	Y: -373.13 nm				
Approach ID: 2009.01.08-18.1	9.16-00002				

The **Info** panel shows data about the settings used in SPM to obtain the data as well as comments that were stored with the curve. The available channels are listed, along with information about the force curve segment (Extend, Extend Pause...) and their control settings for the piezo movement.

X and Y Position show the SPM coordinates for the force curve. The position index corresponds to the numbers in the X, Y position list that was created in SPM to record the force curve. If no particular position has been specified, the index number is set to zero. The position index is also displayed with the marked point in the image viewer.

The Approach ID is a reference number that is updated every time a stepper motor approach is made. Therefore the SPM coordinates from different files with the same Approach ID should be the same. This information can be used to link the force curve coordinates with features in the correct images.

6.3 Saving data and exporting force curves

After processing a force curve there are two options for saving. The data can be saved such that it can be reloaded into the DP program or another mathematical standard program, or an image file of the spectroscopy window in TIFF or PNG format can be exported. Data can be saved by using the **File** pull-down menu, the saving buttons of the short-cut bar or the right mouse button menu.

6.3.1 Save and export of force data

data

As the DP program only reads the jpk-force file format, any force curves that are to be processed further should be saved in this file format using the **data** button or **Save Force Scan**. If the data has been processed then the modified data, not the raw data, is saved.



If force curves are to be read into another mathematical program, they can be **Exported as text** files, either as .out files (**Export as old force format**) or as an ASCII file (**Text export**). Converting curves into .out files is not recommended, since information will be lost (for instance, data collected during pauses and clamps, which were not supported in the old format). The text export produces normal text files containing all the curve data. The text export files cannot be read back into the DP software, all DP processing should be completed before the export.

ASCII Export Default Settings	
Header	
Full settings	
O Channel info only	
Output Unit for Vertical Deflection	
 Force (if available) 	
🔿 Distance (if available)	
⊖ Voltage	
Segments	
✓ extend	
✓ retract	
✓ pause	

Open the **ASCII Export Default Settings** under the Setup pulldown menu.

The **Header** information can be reduced to channel information only.

The Output Unit for the Vertical Deflection can be chosen.

The desired segments for the exported force curves can be selected.

These settings apply for the Text export of all force curves.

There are two scripts to convert force files of the jpk-force format into other file formats. The script "jpk-force-legacyexport" creates .out files, and "jpk-force-export" creates text dump files. Both scripts are used from the Linux terminal.



To run a script, open the Linux terminal window.

The terminal window automatically opens the user specific jpkdata-directory. To apply a script the directory containing the script must be selected ("cd /opt/jpkspm/bin") and finally the script ("/.scriptname") and the corresponding data, which are to be processed by the script, along with the storage directory, are to be specified ("~/jpkdata/directory/filename"). The script then finally processes the file and stores the new file in the same folder. In case that all force files of the file name root "Force....jpk-force", located in the directory jpkdata/Test, are to be converted into out files, the corresponding commands are to be entered:

tneumann@pcc13: /opt/jpkspm/bin	0
<u>F</u> ile <u>E</u> dit <u>V</u> iew <u>T</u> erminal Ta <u>b</u> s <u>H</u> elp	
<pre>tneumann@pcc13:~\$ cd /opt/jpkspm/bin tneumann@pcc13:/opt/jpkspm/bin\$./jpk-force-legacy-export ~/jpkdata/Test/Force*.jpk-force</pre>	

If all jpk-force files of a directory (e.g. Test) are to be converted, either "*.jpk-force" (i.e. without any filename root) is to be entered, i.e. all files of the jpk-force type are processed, or only the directory containing the files is specified with no particular reference to files:

🔲 tne	umann@	рсс13: /о	pt/jpk	spm/bir	1			
<u>F</u> ile <u>E</u>	dit <u>∨</u> iew	<u>T</u> erminal	Ta <u>b</u> s	<u>H</u> elp				
tneuma tneuma	nn@pcc13 nn@pcc13	:~\$ <u>cd /c</u> :/opt/jpk	opt/jp spm/b	kspm/bi in\$./j	<u>n</u> ok-force	-legacy-	export	~/jpkdata/Test

In case that reference to the files is used to convert files (i.e. "*.jpk-force" or "filenameroot".jpk-force" is entered), there is one problem that can occur if a huge batch of curves is to be processed: The filename wildcards are expanded before the command is executed. That means, even if "*.file extension" is entered (which means all files in the given directory with exactly this extension are processed), the script appends one file with the complete filename after the other. And since there is a limit on the allowed length of the expanded command line the script will abort if this limit is exceeded. In such case the directory alone should be specified rather than the filenames.

./jpk-legacy-export ~/jpkdata/experiment/*.jpk-force \rightarrow wildcards limitation

./jpk-legacy-export ~/jpkdata/experiment/ → unlimited number of files

There are additional scripts which can be applied to force curves or force maps, like "splitforcefile", which separates the extend and retract curve into two files, and "splitmapfile", which splits a force map into separate force files.



6.3.2 Export image



The force curves can be exported in PNG or TIFF format for import into other programs, for the production of reports or presentations. The plot, exactly as it is displayed in the spectroscopy window, is exported as an 8-bit file. If a line is drawn in the image or if any operation (like the chain model or Hertz fit) has plotted a fit curve in the force display, these will also be exported.

🗠 Export as Pic	ture	X
Save In: 🗀 X	(anthan_Curves	▼ 🛍 🟠 📴 🖿
	-De -De -De -De -De -De -De -De -De -De	Include filename Transparent background Use a larger font Analysis markers in white nage Size Original size (660x637 pixels) Scaled to
File <u>N</u> ame:	force-Xanthan-2004.11.15-19.46.26-0_OldF	Format.png
Files of <u>T</u> ype:	PNG image	-
		Save

The **Export as Picture** dialog allows many different export options for the graphical image – the file format and content can be modified using the options in this dialog.

The filename can be added as text to the top of the exported image using the tick box here.

A transparent background can be selected. This background may appear black in certain preview programs that do not support transparent format, but in PowerPoint presentations, for instance, this will remove the solid rectangle normally surrounding the image.

6.4 Force curve processing operations

In this section, force curve processing operations are introduced separately. These operations can also be automatically combined and applied to a whole directory of force curves as batch processing. This is explained in **Section 6.4.15**.

6.4.1 (Re)Calibration of V-deflection



This operation allows to add/change or to remove a calibration of the V-deflection after the experiment, i.e. during data processing.



In some cases the cantilever is calibrated after the experiments, for instance because of a sensitive modification/coating or the use of another calibration method than the inbuilt thermal noise measurement. Then the vertical deflection is given in units of Volts.



The **(Re)Calibration** operation allows the calibration or adjustment of the vertical deflection by setting the **Sensitivity** and **Spring Constant**. If no value is set, default values (25 nm/V and 50 nN/m) are applied. Now the vertical deflection is given in units of Force.

The default values can then be changed to the measured or desired values and the vertical deflection is calibrated correspondingly.

If there were already **Sensitivity** and **Spring Constant** values saved in the file, they will be seen here as the default values and can also be left unchanged.

And vice-versa it is possible to remove a calibration, either partly, to display the vertical deflection in nanometers, or completely, to display the vertical deflection in Volts.

Ignore spring constant removes the spring constant of the calibration and gives the vertical deflection in nanometers.







Ignore sensitivity finally removes the complete calibration, and the vertical deflection is given in Volts. If only **Ignore sensitivity** is selected, Ignore spring constant is selected automatically as well.

If the force file is saved anew, the sensitivity and spring constant are still written in the force file and can be used again by selecting **(Re)Calibration** when the saved force file is opened the next time.

Both, sensitivity and spring constant, can also be forgot (**Forget sensitivity/spring constant**), which will remove the calibration of the force file once it is saved anew.

6.4.2 Smoothing of Force Data

all a second

This function allows **Smoothing** of force spectroscopy data. There are several smoothing methods that can be chosen from. The degree of smoothing can be adjusted incrementally.



Force curves recorded at high sample frequencies may be subject to **smoothing** using different methods. Smoothing allows a different weighing of data than down sampling and may be thus preferred to simply record at a lower frequency. Some data also need to be smoothed prior to fitting (see Step fitting in **Section 6.4.9**).

Smoothing method:	Gaussian 🔹
	Gaussian
3moothing width:	Boxcar
	2nd-ord. SavGolay
	4th-ord. SavGolay

There are four **Smoothing methods** that can be chosen from: Gaussian, Boxcar as well as 2nd and 4th-roder Savitzky-Golay.

In the default mode, where **Offset** is selected, the average value is calculated over the selected range. The **Retract** channel is used by default, but this can be changed by selecting **Extend**.

The value is subtracted from the whole curve, and this **Offset** is displayed in the **Baseline** panel.



By changing the **Smoothing width**, the degree of smoothing can be adjusted.

In this example, the Gaussian method has been chosen for smoothing and the smoothing width has been set to 3. The high-frequency noise has been eliminated.

6.4.3 Baseline subtraction

\₽

This function automatically calculates the average value of part of the curve, and subtracts this from the whole curve. This is used to remove the baseline offset in vertical deflection before further processing. Alternatively, the **Offset** can be set by hand (see **Section 6.4.5**). The calculation can subtract either a single value, or a straight line (tilted baseline) from the curve.



In general, for force curves of vertical deflection against position, the part of the curve on the right (far from the surface) should be flat. In this region there is no force between tip and surface, and this gives the force **Baseline**.

Although the force here is usually zero, often when force measurements are made the vertical deflection is not zero. Either the deflection was not set exactly to zero at the start of the experiment, or the deflection may have changed due to environmental factors.





* Spectroscopy: force 2007.09.26-15.21.50 Q 🖷 🛏 I 牟 4 1 🛶 F(1) 👁 View 🕕 Info 40 Automatically subtract the baseline offset. If tilt is selected, a linear fit is subtracted 20 20 Curve Retract -Offset Offset+Tilt Subtract: () () • 40.0 🔺 % Lower extend -100.0 🔺 % Upper -20 -20 Offset: -1.917 V deflection -40 -40 'ertical (mv) -60 -60 -80 -80 -100 15.65 15.70 15.75 15.80 15.85 15.90 15.95 16.00 16.05 Height (measured and smoothed) (µm)

The **Baseline** operation calculates the average value of a certain part of the curve. The range to be averaged is set as a percent of the length. The default is from 90 % to 100 %, i.e. the last 10 % of the curve. This can be set by the user to any range of values.

In the default mode, where **Offset** is selected, the average value is calculated over the selected range. The **Retract** channel is used by default, but this can be changed by selecting **Extend**.

The value is subtracted from the whole curve, and this **Offset** is displayed in the **Baseline** panel.

In some cases, the flat region of the curve may not have an exactly constant value. If there is a linear tilt of the baseline, this can also be removed if the option **Offset + Tilt** is selected.

In the example here, even averaging over 40 - 100% of the curve does not bring the values near the surface to zero. The average baseline value is zero, but there are discrepancies near and far from the surface.



When **Offset + Tilt** is selected, the selected region is used for a linear fit. This straight line is then subtracted from the whole curve. This is sometimes useful, especially for analysis that is sensitive to small deviations from the baseline, such as calculating the area under the curve.

This operation is only suitable for a simple linear tilt. If the overall shape of the baseline is more complicated, then probably some long range forces (e.g. electrostatics) are interacting near the sample surface, and it would require proper modeling to separate the regions of pure indentation and adhesion from a "zero force" baseline.

6.4.4 Contact point determination



This function automatically calculates the point where the force curve crosses the zero force line, and sets this as the zero of the x axis.





In many cases, the absolute position of the z piezo during the force measurement is not interesting. Usually the force curves should be compared using coordinates relative to the sample surface.

The operation looks for the curve crossing zero, so the **Baseline** operation should always be carried out first.

If the force curve is noisy, or the contact region is quite flat, it may be useful to use **Smoothing** to look for the first time the smoothed curve crosses the zero line. The smoothed curve is not plotted, but the contact point is updated.

After the **Baseline** and **Contact point** operations, the zero points of both axes should be set to the surface position. This can be checked by zooming into the contact region in the display.

Note the default for both operations is the **Retract** curve, but it is also possible to set **Extend** if the first contact point with the material should be used as the reference.



6.4.5 Shift origin (manually offset the axes)



This function can be used to shift the offset for the x- and y- axes to set the origin of the force curve where the tip reached the sample surface, for example. The effect is similar to the automatic operations **Baseline** (for the y axis) and **Contact point** (for the x axis), but in this operation the axes are shifted manually.







In the **Offset** panel, the X- and Y- offset can be adjusted manually, or reset to the starting value.

For **Set Y Offset**, multiple channels may be enabled. The list here depends on the selection chosen for display in the **View** panel. If there are multiple entries, click on a channel name to highlight it and make it active for setting the origin. In this case only one channel, **Vertical Deflection**, is displayed, so there is only one entry in the list.

Select **Set Y Offset**, and then click and drag in the plot area to shift the y axis.

The offset is usually chosen so that the flat part of the curve on the right (far from the surface) has a zero value, since it should be the region with no interaction between the tip and the sample. This operation effectively subtracts the baseline for the force curve.

It is often helpful to zoom into the region near the baseline and contact point, to be able to set the values accurately.

Choose **Set X Offset** to shift the x offset by clicking on the plot area. Usually the point is chosen where the force curve (either extend or retract) crosses the zero force line.

There is only one channel available for the x-axis – usually **Height (measured)**. All data channels are shifted simultaneously; if lateral deflection were also displayed here, then the x-axis origin would be shifted by the same amount.

Calculate tip-sample separation 6.4.6



This operation automatically corrects the height signal for the bending of the cantilever to calculate the tip sample separation. This is a very important operation that needs to be applied before the curve is fitted with a polymer chain or Hertz model.



The height signal that is derived from the piezo displacement (either from the piezo voltage or the strain gauge measurement) contains both, the distance the cantilever is moved towards the sample and the bending of the cantilever into the opposite direction. But for the application of chain or elasticity fits, plots of force against tip-sample separation rather than piezo displacement are needed.

If force curve data are loaded, the Vertical deflection is usually plotted against the Height (measured & smoothened) channel.

If Tip-Sample Separation is selected the height signal is automatically corrected for the bending of the cantilever and a new channel, Tip-Sample Separation, is calculated.

The corrected distance is always shorter (force curve is steeper) than the raw height signal, since the cantilever bending occurs into the opposite direction leading to additional piezo movement towards the sample.

This operation is required before any polymer or Hertz fit is applied.

Fit a polymer chain model (FJC and WLC) 6.4.7

0

Tip-sample separation (nm)

W/t
2
_

This operation automatically applies a **Polymer Chain** model fit to the force data. These fits are used to determine the length and the elastic properties of single molecules or domains being stretched between the tip and sample. The Freely Jointed Chain (FJC) and Worm-Like Chain (WLC) models are standard models for the entropic elasticity of straightening a polymer chain from a random configuration.

This operation only applies to force versus tip-sample separation curves, i.e. before the force curve is fitted the Calculate Tip-Sample Separation operation needs to be applied (see Section 6.4.6). For these experiments, the tipsample separation in the adhesive part of the retract curve is the molecule end-to-end length being stretched between tip and sample. It is also necessary to correct the curve for the baseline offset and contact point.

If a whole batch of curves is being processed (Section 6.5), the Filtering Series operation (Section 6.4.12) using the Minimum Value (Section 6.4.10) as filtering parameter can be of help for separating curves with and without unbinding events. Giving a Minimum Value close to the expected force peak values, all curves with no or only rudimentary peaks will be separated from the desired curves. Similarly to that, another filtering parameter can be the Minimum



Position of the **Minimum Value** operation. The first force peak of a reasonable unfolding curve is expected in a range close to the repulsive regime. Thereby the **Minimum Position** can separate curves with improper events far away from the expected position.

This operation only applies to force versus tip-sample separation curves, i.e. before the force curve is fitted the **Calculate Tip-Sample Separation** operation needs to be applied (see **Section 6.4.6**). For these experiments, the tipsample separation in the adhesive part of the retract curve is the molecule end-to-end length being stretched between tip and sample. It is also necessary to correct the curve for the baseline offset and contact point.

If a whole batch of curves is being processed (Section 6.5), the Filtering Series operation (Section 6.4.12) using the Minimum Value (Section 6.4.10) as filtering parameter can be of help for separating curves with and without unbinding events. Giving a Minimum Value close to the expected force peak values, all curves with no or only rudimentary peaks will be separated from the desired curves. Similarly to that, another filtering parameter can be the Minimum Position of the Minimum Value operation. The first force peak of a reasonable unfolding curve is expected in a range close to the repulsive regime. Thereby the Minimum Position can separate curves with improper events far away from the expected position.





All operations should be applied to the **Retract** curve, as the molecule stretching events generally appear as force peaks in the **Retract** curve. Each peak should be fitted separately as an individual stretching event.

Before the chain model fit is applied to a force curve, it is necessary to apply the **Baseline** and **Contact Point** operation (Section 6.4.3 and 6.4.4) as well as to calculate the **Tip-Sample Separation** (Section 6.4.6).

Select **Chain Model Fit** operation icon to apply a polymer model to a force versus tip-sample separation curve.

By default, the chain model fit is applied to the **Retract** curve. This can be set in **Fit Data**.

The algorithm automatically finds appropriate data ranges to apply the fit by looking for force jumps. Each event has a **Fit range** that is shown in the table. Each fit range can be selected separately and the **Fit results** below shows the results for this peak.

To adjust the selected fit range, click and drag in the spectroscopy plot or adjust the **Min** and **Max** values in the table. Fit ranges can be removed with **Delete** or **New** fit ranges can be added (click and drag in the plot to set the fit range for a **New** range). **Recalculate** returns to the automatically calculated initial suggestions.



pm

pm

🔺 nm

The **Fit Parameters** offer various **Model types** – these are discussed in more detail in **Section 6.6.2**. The **Freely Jointed Chain** (FJC) and **Worm-Like Chain** (WLC) are standard models for the entropic elasticity of a polymer chain. Both models are also offered in an **Extensible** version, which includes the effects of directly stretching the chain backbone at higher forces.

There is also the possibility to adjust the **Baseline** and **Contact** position for the fit, as well as the **Temperature**. If nothing is entered here, then the baseline and offset are taken directly as seen in the displayed data – they are not fitted with the model.

The values for the **Contour length** and **Persistance length** can be fixed in the fitting procedure by **Pinning** them. This value is then used for all the events.

The **Fit results** at the bottom show the output from the fit. There is the **Contour length** of the stretched part of the molecule, the **Persistence length** that depends on the model type, and the **elastic modulus** of the backbone if the **Extensible** models are used.

The **Residual RMS** is the RMS of the difference between the fit and the force data, thus describing the quality of the fit. The **Breaking force** and the **Loading rate** at the moment of unfolding are fitted in the peaks of the curves.

6.4.8 Elasticity fit (Hertz models)

V

V

12.80 pN

339.9 pN

22.59 nN/s

Persistence length:

Fit results

Contour length:

Residual RMS:

Breaking force:

Loading rate:

Persistence length:

This operation automatically applies a Hertz fit for different shapes of indenters to the actual force curve to calculate the **Young's Modulus** (Elastic modulus) of a sample. The Hertz model makes assumptions about the sample, for example that it is infinitely thick, homogeneous and purely elastic, so it is recommended to read about this analysis before using this operation (see **Section 6.6.1** for more information about the theory). Since the contact point is a crucial parameter the **Extend** curve is generally used, since the **Retract** curve can contain adhesive interactions that mask the contact point.

This operation only applies to force versus tip-sample separation curves, i.e. before the force curve is fitted the **Calculate Tip-Sample Separation** function needs to be applied (see **Section 6.4.6**). For these experiments, the tip-sample separation in the indentation part of the curve is then the indentation depth as normally discussed in the literature.





All pre-processing operations should generally be applied to the **Extend** curve.

In some cases there is a tilt in the baseline that should be corrected by **Offset And Tilt Correc-tion** (see **Section 6.4.3**). Here it is not crucial to set the x- and y-offset since the baseline and contact point are variable fit parameters. It is important to apply the **Tip-Sample Separation** calculation.

Select **Elasticity Fit** to apply the Hertz model to a force-indentation curve.



By default, the fit is applied to the whole of the **Extend** curve. The **Fit data** sets the curve segment and the fit range with the **Curve**, **X Max** and **X Min** panels. The fit range can also be selected by clicking and dragging in the spectroscopy window.

The choice of fit range depends on the sample and the quality of the baseline. The more data points of the baseline are used, the better the model will fit it. Concerning the indentation depth to be fitted, the Hertz model is only valid for small indentations, i.e. one should know the thickness of the sample. The indentation used for the fit should not exceed 5-10% of the sample height.



The **Tip Shapes** must be selected, since different tip/indenter shapes have different fit equations (see **Section 6.6.1** for the fit equations). Depending on the tip shape the **Radius**, **Half Angle** (cone or pyramid) or **Needle Radius** is to be specified. The **Poisson Ratio** is usually set to 0.5.

Note the differences in the definition of the **Half-angle** for a pyramidal tip. The angle can be measured either to the face or to the corner edge of the pyramid. In general, the cone angles from the manufacturers are defined differently for silicon and for silicon nitride tips – see the diagram in **Section 6.6.1** for more information.

If all parameters are adjusted, the **Fit Results** – the **Young's Modulus**, **Contact Point** and **Baseline** – are shown below. Also the **Residual RMS** is shown, which is the RMS of the difference between the fit and the force data, thus describing the quality of the fit.

6.4.9 Step fitting

710.6 Pa

-261.0 nm

6.615 pN

23.22 pN

۳**ل**سل

Fit results

Young's Modulus:

Contact Point:

Residual RMS:

Show contact point

Successfully fitted data.

Baseline

This function finds steps in the force curve data by fitting a model that is a combination of sharp steps with a slowly varying background (see references, Kerssemakers 2006).



The type of force curves that typically show steps are adhesion curves from cell binding. The steps are usually interpreted as membrane tethers pulled out from the cell surface. These extend at a fairly constant force, before breaking sharply. This gives flat plateau regions in the retraction force, separated sharp steps of a characteristic size.

The model is only designed for regions of force curves that show these characteristic steps. The initial part of the retraction curve shows deformation of the whole cell, and many complex attachments ripping off at the same time. A different kind of model would be required for this region.





The most important initial setting is the range to apply the model. Once the step fitting panel has been opened with the icon, the whole data range is fitted automatically (X Max and X Min is set to ∞). The fitted values will then appear in the step fitting panel. Click and drag in the plot area to select an appropriate fit range. Alternatively, the Start and End values can be set by hand.

The **Position** is the location on the x-axis.

The Height is the change in data channel value at the step (in V, m or N, depending on the force curve calibration.

The Plateau is the x-axis difference to the previous step. This is set to 0 for the first step.

It is best to change the display to zoom into the step region, so that the fitted curve (in green) can be compared with the original data.

Individual steps can be switched off using the tickboxes.



24

200

100

100

-300

400

Fit data

Segment:

X Channel

Y Channel:

Х Мах:

 \times Min:

detrectio

Ketr

(pN) -200

Fit parameters Smoothing: Significance

🗌 Only positive steps

Slope fitting

Save Step Table

Max. fit length: 🔻 Found 19 steps

Only fit to right of minimum

F(4) View 🕥 Info Identify and quantify steps on a force-distance curve.

Retract

•

-

Tip-samp. sep

Vertical deflection

∞ 🔺 μm

-00 🔺 µm

3.0 🔺 0.0100 🔺

> Plateau -0.00 μm 0.09 μm 0.14 μm 0.07 μm >>>

200

100

Extend (pN)

deflection: -100

/ertical

-200

-300



The model is a combination of a smoothly varying background curve and sharp steps. The **Smoothing** parameter sets the length scale for the smoothly varying background. The steps are found in order of statistical significance until the **Significance** threshold is reached.

When the **Smoothing** is reduced, this allows for a more sharply changing background curve. Therefore fewer steps are found, because irregularities can be followed reasonably well with the background curve.



Most of the steps in this part of the curve are fairly clear, but there is a feature for instance at around 20 microns on the x axis that does not fit into a clear step shape. In this case, where the Smoothing is set to 2 pixels, the background curve follows the deviation.

Here, the Smoothing has been increased to 15 pixels. The background curve cannot react so sharply, so more steps are needed to model the data. Two steps have been introduced around 20 microns.

The **Significance** limit has the opposite effect – decreasing the value generally increases the number of steps found.

The **Only positive steps** feature helps to remove unwanted negative steps.

For cell adhesion curves, for instance, only upward steps are expected. Artifacts can have the form of downward steps and, depending on smoothing, ca be detected as step features. If **Only positive steps** is selected, only upward steps are allowed.

The upper curve shows 5 steps at around 2.8 microns that are reduced to 2 steps, if the **Only positive steps** tickbox is enabled (see curve below).









The step fitting operation automatically applies to the whole data range. In the majority of cases, step finding is only interesting after the first minimum. Only fit to right of minimum ignores steps left of the minimum and thus is a helpful tool for automated batch processing, since it can replace the manual setting of the fit range.

The right curve shows 3 steps left of the minimum. If Only fit to right of minimum is used, step fitting ignores those steps (see curve below).



∞ 🔺 μm

-∞ 🔺 µm
📉 Save Step	Table	×
Save <u>I</u> n: 🗀 j	okdata	- 🛍 🚵 🔡
🗀 configurati	on	
Screensho	tsManual	
File <u>N</u> ame:	steps.afm-steps	
Files of Tupo.	ASCII file (*.afm-steps)	
Files of Type:	L	

Once the settings for the step fitting are reasonable, the table of values can be saved from the software using the **Save Step Table** button in the operation panel.

The save dialog shown here prompts for the location and name of the file.

🕎 force-save-2006.04.27-14.13.20).afm-steps (~/jpkdata/CHdataf	romKate) - gedit	_ 0 ×
File Edit View Search Tools Docu	uments Help		
New Open Save Print	ndo Redo Cut Copy Paste F	a 🥙 nd Replace	
force-save-2006.04.27-14.13.20.afm	n-steps 🗙		
# date: Fri Feb 29 11:53: # force scan: /home/rache # interval start: 5.27E-5 # smoothing width: 5.0 # interval end: 8.75E-5 # smoothing width: 5.0 # columns: Index Position # columns: Index Position # columns: Index Position 0 5.6982980e-05 0. 1 6.693994e-05 0. 3 6.693994e-05 0. 4 6.996057e-05 0. 5 7.1246737e-05 0. 8.3139734e-05 0. 7 8.3139734e-05 0. 1 1 2 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	<pre>13 CET 2008 //jpkdata/CHdatafromKat (in m) Height(in N) Pla 000307260 -0.0000000 072611928 1.2772580e-04 1.0040542 6.80761083e-04 1.0040542 6.80761083e-04 1.0040453 2.20866807e-04 0.59545083 1.1871532e-0 1.28945001 2.1464075e-04</pre>	e/force-save-2006.04.27-14.13.20.out teauWidth(in m) p-Value 0 5.0445951e-36 5 3.7015926e-29 5 1.2215676e-164 5 1.7925267e-67 5 3.895997e-72 5 3.895997e-72 5 3.895997e-72 5 3.8958947e-19 5 5.348104e-19 8 2.8568847e-95	

The data is always saved as a plain text (ASCII) file. The final data column, p-Value, is a measure of the significance of the step. A smaller value gives a larger statistical weight to the step.

6.4.10 Minimum value



This function calculates the minimum value of the force curve. If this is performed after the Baseline operation, this gives a measure of the maximum adhesion.

Ln 1, Col 1



The **Minimum** function displays the lowest value read from the curve along with the position information.

This operation is designed to be used after the **Baseline** operation, as shown here, where the zero force level has already been set. In this case, the **Minimum** function gives a measure of the maximal adhesion (in this case 82.02 mV). If this operation is used on a force curve where the deflection has been calibrated in Newtons, then the adhesion value here is also in Newtons.

The data is read from the **Retract** channel by default, it can also be set to the **Extend** channel.



6.4.11 Area under the curve



This function calculates the area enclosed by the force curve and the x axis. If this is performed after the **Baseline** operation, this gives a measure of the work (energy) required to remove the tip from the surface. If viscoelastic contributions to the energy are negligible, this is equivalent to the adhesion energy. Calibrated force curves (deflection in Newtons) give an area under the curve in Joules.



The function calculates the integral of the main part of the force curve that lies beneath the x-axis. This operation only makes sense after the **Baseline** function has been applied, so that the zero force part of the curve on the far right lies on the x axis.

The region with the largest continuous negative integral is automatically selected. The region is marked in the force curve display. The data is read from the **Retract** channel by default, it can also be set to the **Extend** channel.

6.4.12 Measure the slope of the curve





The **Slope** value is calculated from a linear fit, as shown in the graphic. There is one fit parameter, the **Fit Length**, which must be set shorter than the steep straight part of the force curve. The default value is 50 nm.



6.4.13 Measure distance



This analysis function measures the distance between manually set points in the force plot, to mark and store values from the data.



When **Set Line** is selected, the mouse can be used to click and drag on the plot area, and the values of **Delta Y** and **Delta X** are shown for the two points selected. The option **Choose file for Save Line** can be used to set a file name and location for the data, and then measured values can be saved as an ASCII text file using **Save Line** for each set of values measured. Values from many different force curves can be saved into the same file.

Clicking **Set Line** again removes the operation from the register.

Save Line creates a text file that contains delta x and y, the x and y start and end coordinates as well as the file name of the force curve including file location. The file name and data directory where the file is supposed to be saved can be set by **Choose Filename for Save Line**.

6.4.1 Find the height corresponding to the setpoint

- 🖻 🖄 🐯 🚍

Open Cancel

م۔۔۔

File Name:

Files of Type:

🗠 Choose File for Save Line

🗀 2um-SphericalIndenter CHO

line-measurements.txt

PyramidalIndenter_CHO
 jpk-app-elastic-modulus.pdf

Look In: 🗀 Elasticity

This operation measures the Height value corresponding to the setpoint, i.e. the height when the setpoint has been reached.



The register card of **Find the height corresponding to the setpoint** allows for selecting either the extend or the retract segment of the force curve. Height or Height (measured) can be used as X Channel. Finally the **Setpoint Height** is displayed below.



6.4.2 Save/Load Process

Ð	Full Range
Q	Zoom
dete	Save Force Scan
PIC	Export as Picture
	Export as Text 🔹 🕨
	Save Process
	Load Process
Ň,−	Analyze Slope
*+	Measure Distances

Save Process allows saving of a series of force curve operations. The resulting process file contains the order of the operations as well as the parameters that have been optimized for the corresponding curve, such as fit ranges or smoothing. These files can be loaded and applied to other curves, which can be very useful for automated and reproducible processing (see batch processing in **Section 6.5**).

To save or load a process, right click in the force curve oscilloscope, where **Save** or **Load Process** can be selected.

🔼 Save the	e list of operations as .jpk-proc file			×
Save In:) jpkdata	•	۵	
File <u>N</u> ame:	HertzFit.jpk-proc-force			
Files of <u>T</u> ype	e: JPK force-scan series process			•
		Sav	re C	ancel

🛎 Load a lis	t of operations from a .jpk-proc file	9		
Look <u>I</u> n: 열 j	pkdata	•	۵	
🖹 HertzFit.jpl	c-proc-force			
File <u>N</u> ame:	HertzFit.jpk-proc-force			
Files of <u>T</u> ype:	JPK force-scan series process			-
	[Ope	en C	ancel

Save Process opens a file browser where the process can be saved. The process is saved as "jpk-proc-force" file. This file can be opened to process other single force files or a batch of curves (**Section 6.5**).

Correspondingly, **Load Process** allows for browsing and loading of jpk-proc-force files to apply to the actual curve.

6.5 Batch processing

Using **Batch processing**, several processing operations can be combined and applied automatically to a large number of force curves. In each case, the operation functions exactly the same as for individual force curves. The description here is of the batch processing as a whole; please see **Section 6.4** for details of the individual operations.



The **Batch processing** is started by using this icon to open a file browser to select the directory of force curves.

		PyramidalInden	ter_CHO (10 curves)
		Segment Channels:	Extend Height Height (measured) Time Height (meas. smth.)
		Date:	8/6/08 1:13 PM
		Force Settings:	relative closed loop
		Z Length:	4.0 μm
ile Nome	/home/tpeumapp/inkdata/Br	eispieldaten/Elasticity/Pyram	idalindenter CHO

Browse

Empty-process

Step-fit

Hertz-fit Molecular-chain-fit

Clamp-step-fi

🔷 Next

Cancel

🥃 Batch Processing

Define batch process

Load pre-defined process

Results file saving options

Save curve position in file

Load saved process:

The batch processing applies automatically to all the force curves in the chosen directory. The output is saved to this directory at the end.

In the file chooser, the individual force curves are not shown, just the information about the whole set. Select the directory as normal. The number of force curves found is displayed, plus the information from the header of the first force curve.

Use groups of files that have the same data, i.e. the same measurement, *with the same type of calibration* i.e. data in the same units (V, nm or N).

Choose **Open** to set the directory and go on to the next step. Once the directory of force curves has been set, the operations or functions have to be selected.

In the step **Define batch process**, pre-defined sets of operations can be chosen. By default, an empty process is chosen.

Previously saved processes (see below for details) can be reloaded under **Load saved process**. Browse for the directory the process is saved in and select the process.

JPK also offers a set of **pre-defined processes**, such as **Clampstep-fit**, **Hertz-fit**, **Molecular-chain-fit** and **Step-fit**. Choosing a process means that a number of operations are already selected for the processing of data, namely the ones that are interesting for the particular experiment.

In case an empty process is chosen, all the operations will have to be selected manually.

Save curve position in file will create another three columns in the results file, containing the position index as well as the x and y position of the curves relative to the image viewer.

Choose Next to continue.

Before the operations are carried out, it is important to set which data should be saved at the end. The summary data (a text file "results.txt") with the individual output values will automatically be saved to the same directory as the raw data.

There is a further option to save the full set of processed force curves individually (e.g. with the **Baseline** and **Contact Point** corrected). This is convenient for instance if the curves are needed later for display, but remember that the curves are essentially duplicated in terms of disk space. The option to discard force curves during the processing means that only the useful curves are duplicated. The curves will automatically be saved to **Folder for mod-ified force curves**.



JPK Instruments

Header

- Full settings
- Channel info only

Output Unit for Vertical Deflection

Force (if available)
 Distance (if available)
 Voltage

Segments

extend

🗹 retract

🗹 pause

Channels

- ✓ Height (measured & smoothed)
- Height (measured)
- 🗹 Height
- Segment Time
- Series Time
- Vertical deflection

For further data processing in different software than DP, it may be convenient to **export** the force data **as text** files. Tick the according box if you wish to save the modified force curves in text format rather than JPK-file format. Keep in mind that uncompressed textfiles are larger and that they cannot be read back into the DP software.

There are several text export options that help to reduce the data. If **Channel info only** is selected rather than **Full settings**, the **Header** is reduced to the basic information such as datadescription and channel information. Even the **Output Unit for Vertical Deflection** can be selected here. The **Segments** and **Channels** options allow for reducing the segments and channels saved.



The **Batch Process** window is then opened, where all the force curves and operations are shown. The curve selected in the list is shown in the display window, as well as the history bar of pre-selected operations. You can scroll through the operations and eventually insert extra operations, for instance to measure the adhesion on both the **Extend** and **Retract** parts of the force curve. Once the first curve is accepted, it is not possible to add or remove processing operations.

In case an empty process has been chosen, the operations will have to be selected from scratch. Not all operations need to be applied, just the ones that are interesting for the particular experiment. It is however recommended to always use the **Baseline Offset** so that the zero force line is set correctly for the operations that follow.

Check that the settings and operations are correct for the first curve, before progressing to the next force curve. It is possible to change the parameters for each curve separately in the software, but generally most batch processing is based on using the same parameters for each curve, so that the results are comparable.

To go to the next curve select **Keep** or **Discard**. **Keep** will include the results of the actual curve in the results file, and save the modified curve if it was selected at the start. **Discard** means that neither the fit data nor the modified force curve will be saved. In this way, each operation and curve can be checked if required, to see that the values or ranges are sensible for each curve and which curves contain relevant data. **Save partial results** give the ability to save the results even when unprocessed data are existing.



To sort force curves by the result of the applied operation, the **Filtering Series** operation (**Section 6.4.12**) can be used. The selection of a threshold finally allows separating the curves into two folders, "filter-group-0" and "filter-group-1". See **Section 6.4.12** for more details.

The behavior of the operations is exactly the same as for individual curves, as described in **Section 6.4**. It is recommended to test the operations on single curves first to become familiar with the operations. Once the parameters are adjusted for one curve they will automatically be used for the next curve, unless they are modified again. That means that all parameters can be adjusted for each curve separately if required. If parameters are left at the default values, for example using the full fit range for the Hertz fit, then the full range will be used for each curve even if the data have different lengths.



As described in **Section 6.4.15**, series of force curve operations can be saved and loaded. The process files contain the order of operations as well as the parameters that have been adjusted to the processed curve. A sample curve can be loaded and the parameters optimized. The corresponding process file can then be used for automated and reproducible processing of a batch of curves.

Right click in the force curve oscilloscope to **Save** or **Load a Process**. A file browser will open to save/load processes.

-1 -300 -200 -100 0 100 Height (measured & smooth	0 -1 200 300 400 (nm)	
force-save-2008.09.15-17.09.47.out force-save-2008.09.15-17.13.14.out force-save-2008.09.15-17.13.24.out force-save-2008.09.15-17.13.45.out	unprocessed unprocessed unprocessed unprocessed	Open force curve Keep Discard Undo
force-save-2008.09.15-17.13.55.out force-save-2008.09.15-17.14.11.out	unprocessed	Keep and apply to all
force-save-2008.09.15-17.24.42.out	unprocessed	Processed: 0
force-save-2008.09.15-18.45.22.out	unprocessed	✓ Unprocessed: 18

The **Open force curve** button will open the actually displayed curve in a new window, where it can be processed like a single force file. This can be helpful, for instance, if one curve of a batch is selected to optimize the processing parameters. Batch processing is first used to scroll through all curves to find a sample curve, which is then opened separately to adjust all values for the corresponding processes. The process can be saved and finally applied to the whole batch of curves.

On changing from one curve to the next, there are two different display options. If **Autoscale XY** is selected in the oscilloscope toolbar (highlighted with a red circle in the above screenshot), then the full data range will be shown for each curve. If it is not selected, then the same axis ranges are kept for each successive curve.

Keep and apply to all will apply all operations with the same parameters to each curve successively through to the last force curve. This is equivalent to clicking **Keep** for each curve in turn without adjusting any parameters.

Once curves have been processed or discarded, the button **Undo** will become active. This cancels the last **Keep** or **Discard**, going one place back up the list of force curves and removing the last set of parameter changes.





*results.txt (~/jpkdata/TestCurves-processed)	- gedit			_ D X
Ble Edit ⊻jew Search Tools Documents Help				
New Open - Save Print 5 Cot	Copy Paste Find Replace			
*results.txt x				
F1 lenger [] F1 enge sawe 2006, 12, 22, 215, 41, 45, out force-sawe 2006, 12, 22, 14, 44, out force-sawe 2006, 12, 22, 15, 41, 45, out force-sawe 2006, 12, 22, 15, 41, 51, 44, out force-sawe 2006, 12, 22, 15, 41, 54, out force-sawe 2006, 12, 22, 15, 42, 20, 01, force-sawe 2006, 12, 22, 15, 42, 20, 01, force-sawe 2006, 12, 22, 15, 42, 20, out force-sawe 2006, 12, 22, 15, 42, 20, out force-sawe 2006, 12, 22, 15, 42, 20, out force-sawe 2006, 12, 22, 15, 45, 20, out force-sawe 2006, 12, 22, 15, 45, 20, out force-sawe 2006, 12, 22, 15, 45, 30, out force-sawe 2006, 12, 22, 15, 45, 51, out force-sawe 20	Beseline Offset (N) 0.14655456507182702 0.15662285335346423 0.15662285335346423 0.15662285435346423 0.15672255627600057 0.2115442460550022 0.255225562760075737864116951 0.2554225562760075737864116951 0.3213762156234187 0.3213762156234187 0.3213762156234187 0.3213762156234187 0.3213762156234187 0.3213762156234187 0.38219521562343837 0.6861065271186234187 0.17970146249121422 0.1797014624912142 0.1797014624912142 0.13941706871557816 0.2774185948671557816 0.3274185948671557816 0.3274195948671557816 0.3274195948671557816 0.3274195948671557816 0.3274195948627553914 0.3274195948622553914 0.3274195948622553914 0.3274195948622553914 0.32741959486225539314 0.3274195934623353463353463353448355	Michaue (N)	Area [J] 2. 63820188239124E-9 4. 64538970721460855-10 1.83913[2]405631862-10 1.83913[2]405631862-10 3.13944518057086481-12 3.026875580560283-12 1.82584518027269566283-12 1.8258451802726956283-12 1.63544232124271E-11 5.02442724025474E-13 1.63544232124271E-11 5.2044227610333345E-12 6.42064813033345E-12 4.6205419051333345E-12 4.62054190533345E-13 4.6325857195033345E-13 4.6325857195033345E-13 4.63258571950335496E-13 4.6325857195035405E-13 4.53254559504955-13 4.5325452507142725546E-12 2.45255396035475E-14 2.55155539603547E-12 2.5515553960033167E-14 2.65755196245E-12 2.5515553960033167E-14 2.67574255166445E-12 5.5515535960033167E-14 2.67574255166445E-12 5.5515535960033167E-13 3.651555196644E-12 5.5515535960033167E-13 3.651555196644E-12 5.5515535960033167E-13 3.65155196644E-12 5.5515535960033167E-13 3.65155196644E-12 3.65155196644E-12 3.67574255196644E-12 3.67574255196644E-12 3.67574255196644E-12 3.67574255196644E-12 3.67574255196644E-12 3.6757425196644E-13 3.6757425196644E-12 3.6757425196644E-12 3.67574525196644E-12 3.675745255196644E-12 3.675745255196644E-12 3.675745255196644E-12 3.675745255196644E-12 3.675745255196644E-12 3.675745255196644E-12 3.675745255196644E-12 3.675745255196644E-12 3.67574525519545551555555555555555555555555555	4
1			Ln 1, Col 1	INS

The results can only be saved when all curves are processed (or discarded) and the last curve is reached. Then the **Save final Results** button will be enabled and can be used to finish the process, save the results file and (if selected) save the modified force curves.

The **Abort** button will stop the **Batch Process** without saving any data (after confirmation).

The results file name is shown in the status at the bottom of the **Batch Process** window. This includes a time and date so that the same force curves can be re-processed (perhaps with different operations).

In addition to the main overview results file, there are separate results files for operations that generate open-ended data. For example, **Step fitting** and the **Polymer Chain** models find an open number of steps or force jumps. These operations generate one extra results file each, which contain these full lists of data.

The file results.txt , contains the summary outputs from all the selected functions. Here there is a fixed set or results for each force curve in the list. Each force curve has one line, with the results of the different operations appearing as columns

Note that for all the results files, the units are taken from the first curve in the batch directory. *Do not mix curves with different units*, i.e. all the force curves should have the same type of calibration (V, nm or N). The **(Re)Calibration** operation can be used to make sure that all the force curves have the same units, but care must be taken that the calibrations used are correct for all the force curves.

The **Step fitting** and **Polymer Chain** results files are created separately and contain one row for each event of a force curve, with the fit results for that step or jump listed as columns. Therefore each force curve can have multiple entries, depending on the number of events found.

6.5.1 **Histogram option**

Partial or final results can be shown in a histogram for further analyzes in Data Processing.



3.0

0.5

1.0 1.5 2.0 [2] Young's Modulus (MPa)

The Show Histogram button will open the Results Histogram window. This window can be helpful to have a short overview about the distribution of different results. Furthermore it is possible to use a gauss fit to determine the mean value and standard derivation of the results in a specific range.

The Results Histogram window shows a histogram of the used batch processing operations. All calculated results can be selected. The display of the histogram can be adjusted by the chosen Bins and displayed Axes.





6.6 Filtering Series

 \diamondsuit

The **Filtering Series** is a function that is particularly interesting when using Batch Processing (see **Section 6.4.15**). It filters a series of data processed with Batch Processing according to a chosen parameter into two groups. It can be used with basically every operation that returns a value. The parameter fitted by the operation can be used as a filtering criterion to separate the data into two groups: the one that obeys the criterion and the one that does not. The two groups are referred to as **Group 1** and **Group 0**, respectively. Only one **Filtering Series** can be performed during a Batch Process.

If data are supposed to be filtered in respect to several conditions, the Batch Processing has to be performed repeatedly including a new filtering criterion. Choose the data from a group selected in the preceding step and apply another **Filtering Series** onto an operation.

There are two filtering modes, Basic and Advanced. In the "Basic" mode of the filter operation only one result of the last operation can be evaluated (e.g. parameter <>= value). The "Advanced" filter mode allows the evaluation of multiple criteria from any applied operation (or combination of operations) in one step.

6.6.1 Basic Filtering



Parameter:	Fitted Segment Count	
Comparison:	Fitted Segment Count	
Companson.	Any X Min	
Value:	Any X Max	
	Any Contour Length	
Current curve:	Any Bending Length	
Current curve.	Any Residual RMS	
	Any Breaking Force	
	Any Critical Loading Rate	

Parameter:	Fitted Segment Count	•
Comparison:	parameter ≥ value 🔻	
Volue:	parameter ≤ value	
value.	parameter ≤ value	
	parameter ≥ value	
Current curve:	parameter ≥ value	

Load a batch of data with the **Batch Processing** operation. Choose the operations that are supposed to be performed. After the operation that includes the criterion that is supposed to be used for the filtering of the data, add a **Filtering Series** operation. In the example given, the parameters calculated in the worm-like-chain fit are used as criteria in the **Filtering Series**.

The **Filtering Series** operation does not necessarily need to be the last operation, as it is the case in this example. Further operations can still be added after the Filtering Series.

A list of **Parameters** is offered that can be used as a filtering criterion. It consists of all the parameters that are evaluated – be it calculated or fitted – in the preceding operation. From the drop-down list, select the **Parameter** you want to use as a criterion to filter the data into two groups.

In the example given, the number of segments fitted with the worm-like-chain model in the given file is used as filtering parameter.

In the next step, choose the type of **Comparison** you want to use for the filtering. You may choose the parameter to be greater or equal to or smaller or equal to a certain value. It is also possible to use the absolute value of the fitted parameter for comparison.

Parameter:	Fitted Segment Count 🛛 👻
Comparison:	parameter ≥ value ▼
Value:	▼ 3.00 ▲
Current curve:	Group 1

The last filtering setting is the **Value** that is used as reference for the comparison. Type in the number or use the increment arrows to increase or decrease the value. Any file where the comparison of the fitted parameter with the **Value** is positive is assigned to **Group 1**. If the comparison is negative, the file is assigned to **Group 2**.

6.6.2 Advanced Filtering

The user defines a filter expression that will be evaluated. Normally this should have a Boolean (true or false, 0 or 1) as result. Based on this result, the force curves will be sorted into groups (subfolders: filter-group-0, filter-group-1) for later analysis. (Note: it is also possible to generate other nonnegative integer values, in which case the force curves can be sorted into more than 2 groups.) The expression can be typed directly into the "Expression" text panel, and text can also be inserted automatically using the context menu. The results of the operations can be combined with logical operators and threshold values. The final text must be a valid Python expression.

1. Accessing the results from processing operations

The filter needs to be able to access the results from the previous operations in order to use them in an expression to generate the filter output. The context menu is useful to select from a list of valid names for the results that are available. Click with the right mouse button in the "Expression" text field to insert text selected from a list of valid options for the current set of operations. Screenshots of the context menu options and final expression for an advanced filter:

- F(4) \ 👁 View \ 🕦 I	info \		w \ 🕜 Info \	
Filter force-scan series based on previous results for batch processing.		Filter force-scan for batch process	Filter force-scan series based on previous results for batch processing.	
Ref. Operation Step Fit		Ref. Operation S	tep Fit	
⊖ Basic		⊖ Basic		
Parameter Ste	p Count 👻	Parameter	Step Count 👻	
Comparison Par	rameter ≤Value 💌	Comparison	Parameter ≤ Value 💌	
Value 💌	1.00 🔺	Value	▼ 1.00 ▲	
 Advanced 		 Advanced 		
Expression:		Expression:		
step_count steps. results[-1]. results[-2]. Results[-3]. Current Curve G	رچھاڑی step_position step_height plateau_width p_value slope loading rate	any((steps.step_os (steps.step_pos (steps.step_hei < -7e-3)) Evaluate Synta Result Current Curve	_position > 100e-9) & sition < 200e-9) & ght > 0.1e-9) & (steps.slope x Help Group 1	
	slope_fit_length step_force			

Different operations in DP generate different output, and there are various options for the types of results:

- **No result**, e.g. The operation "Tip-Sample Separation" modifies the force curve, but does not return any specific value. This type of operation does not generate anything that could be used for filtering.
- **Single values**, e.g. The operation "Find Contact Point" returns one value contact_point_offset for the position where the contact point was found.

Note that one operation can return multiple single values, e.g the operation "Curve Minimum" returns both the



minimum value and the x_location where it was found. These results have different names, and there is only one minimum position, so each name stands for just one value.

Most single value results are floating point numbers (**floats**), i.e. values that may be expressed with a decimal point and exponent, and often with a choice of different units, e.g. the minimum value or x_location mentioned above.

Some single values are **integers**, e.g. step_count from the operation "Step Fit" or fitted_segment_count for the WLC/FJC operation "Chain Model Fit".

• An array of values, e.g. the operation "Step Fit" finds a number of steps that depends on the actual force curve data. The results for step_position or step_height are arrays of values for all the steps that were found.

There is a defined way to access the results of the previous operations:

results[index].resultname.units

results[index] defines which operation is referred to. The operations are referred to by their position in the list of operations. The index counts back from the filter operation. e.g. results[-1] is the last operation before the filter, results[-2] is the operation before that. (The identifier "results" is an array of the results of all operations applied before the filter operation. If the results[index]. part is omitted, then it defaults to the last operation before the filter.)

resultname is the name of one of the results from this operation.

units defines which calibration slot (set of units) the value should have. For instance, the vertical deflection may be calibrated as force or distance, or may be the original measured volts deflection. The calibrated values are only available if the current force curve has a calibration applied, otherwise an error will be seen. The units are optional; if they are not explicitly defined, then the default units will be used, depending on the calibration state of the force curve.



The full set of valid names is called the namespace of the expression, and can be seen in the context menu. The different operations and results are listed as a tree diagram so that the names do not have to be remembered.

Example		
Consider the following operation histor	y applied to a force curve:	
	\prec	
1. Original file	no result	
2. Subtract Baseline Offset	index = -4 \rightarrow results[-4]	
3. Find Contact Point	index = $-3 \rightarrow$ results [-3]	
4. Tip-Sample Separation	no result	
5. Chain Model Fit	index = -1 \rightarrow results[-1]	
6. Filter		
These examples would generate valid	result options for this example:	
results[-4].baseline_offset.volts		
The value of the baseline offset in volts.		
results[-1].chainfits.breaking_force.force		
An array containing the values of the breaking force for all the steps that were found, calibrated in N (so long as the force curve itself has been calibrated).		
chainfits.breaking_force		
Sometimes shorter versions can be used, so long as the defaults are clearly understood. The last operation before the filter is the default, and can be used without specifying results[index]. The first calibration slot listed in the context menu is also the default (here, force). So for this case the shorter version is equivalent to the longer version above.		

2. Logical Operators

In general, the results from the different operations are compared to some threshold values in an expression which evaluates to a Boolean result (True / False, 1 / 0).

The standard comparison operators can be used:

>	greater than
<	less than
>=	greater than or equal
<=	less than or equal
==	equal
!=, <>	not equal

The results of such comparisons can be combined using logical operations. There are two different sets of operations with a very similar function. The choice of which to use depends on the type of values that are being compared.

To compare Boolean single values:

and	logical and
or	logical or
not	logical not



To compare logical arrays:

&	logical and	
I	logical or	(pipe symbol)
logical_not	logical not	

(The operations **and** or **or** are not suitable for comparing logical arrays. The operations **&** or **|** could be used in either case, but the operations **and** or **or** have the advantage that the right hand side is not evaluated if the left hand side is false. Examples using this are shown later.)

In the case of operations that return an array, the elements in the array should be reduced to a single value, for example by using the keywords **any** or **all**. The operations **&** or **|** should always be used inside the **any** or **all** expressions rather than **and** or **or**. Alternatively, individual elements in the array can be accessed directly by their index (starting from zero).

3. Using filter expressions

The expression shown in the text field is evaluated when the "Enter" key is pressed or the "Evaluate" button is clicked. The **Result** shows the classification of the current curve – normally "Group 0" (expression returns False or 0) or "Group 1" (expression returns True or 1). If there is an error in the expression so there is no valid output from the filter, the curve will be set as unclassified (shows "Group n/a").

Simple comparisons

The simplest way to filter force curves is to compare one result with a fixed threshold value – the force curves are separated into groups 1 and 0, depending on whether the condition is true or false.



Combining criteria

Any valid result from any of the operations can be combined with logical operations to form a more complex expression.

It is strongly recommended to use brackets to make it clear which parts of the expression belong together. Otherwise the order in which parts of the expression are evaluated may not be obvious, and the expression could give unexpected results (see notes on array type output in the next section).

Example		
Define a range of values for the output from "Find Minimum"		
(results[-1].minimum.force > -200e-12) and (results[-1].minimum.force < -100e-12)		
The expression is True (curve will be assigned to group 1) if the minimum value is between -200 pN and -100 pN.		
Combine criteria referring to "Find Minimum" and "Area under the Curve"		
(results[-1].minimum.force < -2.3e-9) or (results[-2].area > 7.2e-14)		
The expression is True if the minimum in force is less than -2.3 nN or the area under the curve is greater than		

Using array type results – steps and events

7.2 x 10⁻¹⁴ J

It is possible to do the same type of comparison and combination for array-type results. However, special care is needed to ensure that the filter is valid for all the curves, as the number of results are not known in advance. Please read this section carefully, or batch processing may generate unexpected errors!

What happens if there are no steps?

For a simple comparison, it is probably not surprising how the opeators any() and all() are defined. However, when there are no steps it is not immediately obvious what the result will be. The mathematical logic for any or all for an empty set is as follows:

any(results[-1].steps.step_height.distance > 3e-9)

This is True if there is any step with height greater than 3 nm.

It is False if there are no steps.

all(results[-1].steps.step_height.distance > 3e-9)

This is True if all steps have a step height greater than 3 nm.

This is True if there are no steps.

The results for the individual step parameters from the step and chain fit operations do not exist if there is no step or event from the fit. Therefore it is possible to write a filter that works well for the example curve with steps or events, but fails on batch processing because the curves without steps or events generate errors.

In the logical Python expression it is recommended to make an explicit check at the beginning whether any step or event was found, to prevent the filter failing for example by trying to access a step height that does not exist. If this first check is combined using a logical **and** with the other conditions, then the second part will only be evaluated if there



was a step, and there will be no problems with missing values.

```
(step_count > 0) and (any(steps.step_height.distance > 3e-9))
```

If there were no steps, the first part is False, therefore the second part is not evaluated, because the whole expression must be False. Output is group 0.

If there are 1 or more steps, the first part is True, and the second part is evaluated. The state of the whole expression is the same as the state of the second part: this is True if there is any step with height greater than 3 nm.

What happens if there are more than one steps or events?

Care is also needed for comparisons where one side might have a different type than the other. This expression, for instance, looks quite similar to the one above:

(step_count > 0) and (steps.step_height.distance > 3e-9)

Do not try to use this expression in a filter! The step_height is an array with a variable length. The step count is always an integer, and there will be problems if the **&** operator is used to compare a single logical value with an array of logical values. In this case it is essential to use any() or all() so that two single values are compared and the logic is clear for when the overall expression is True or False.

Note that if arrays have the same length (e.g. the same result is tested more than once) the comparison between arrays is valid. The following expression generates a logical array where each WLC/FJC fitted segment is tested to see if the contour length is between 10 and 100 nm:

(chainfits.contour_length.nominal > 10e-9) & (chainfits.contour_length.nominal < 100e-9)

To use this test as part of a valid filter expression, the whole text should be enclosed in any() or all() to generate a single True or False value for the filter output:

```
any((chainfits.contour_length.nominal > 10e-9) & (chainfits.contour_length.nominal <
100e-9))</pre>
```

This is True if any of the individual events have a contour length that is between 10 nm and 100 nm. For example if 2 events were found with contour lengths of 5nm and 110 nm, then the expression would be False.

```
any(chainfits.contour_length.nominal > 10e-9) and any(chainfits.contour_length.nominal
< 100e-9)</pre>
```

This is True if any of the events separately have contour lengths greater than 10 nm and less than 100 nm. For the example above of 2 events with contour lengths of 5nm and 110 nm, then the expression would be True.

Accessing individual elements of an array result

Individual elements in the array can be accessed directly by their index. The index for "Step Fit" runs from 0 for the first step to step_count-1 for the last step.

steps.step_height.distance[2] > 3e-9

will compare the third step's height with 3 nm.

(steps.step_height.distance[0] > 3e-9) and (steps.step_height.distance[1] < 5e-9)

is True if the first step is bigger than 3nm and the second step is smaller than 5 nm.

Note that it is important to make sure there are no attempts to access steps that do not exist! So in this case, there must first be a test that there are really 2 or more steps. The full filter text would therefore be:

(step_count >= 2) and (steps.step_height.distance[0] > 3e-9) and (steps.step_height.distance[1] < 5e-9)</pre>



Other integer output

A filter expression may also return nonnegative integers other than just 0 and 1. A simple example is to separate the force curves according to the number of steps:

results[-1].step_count

The output folders are named with the integer result of the filter i.e. a force curve with 4 steps will end up in the subfolder filter-group-4, etc.



6.7 Theory

Elasticity fit equations for different indenter geometries 6.7.1

This section describes the background to the elasticity fit operations described in Section 6.4.8. The Young's Modulus is an elastic property of a material, and is defined as the stress of a material divided by the strain. This is a normalized measure of the compressibility - the higher the value the stiffer is the sample.

Young's Modulus



If a piece of material is compressed homogeneously, the calculation of the Young's Modulus is straightforward. For AFM measurements, however, the indentation geometry is more complicated, because the surface is locally indented with a specific tip shape and fitting is required. The Hertz model is the standard model used to analyze AFM forcedistance curves to extract the elasticity. However, the Hertz model makes serious assumptions about the sample, for example that it is infinitely thick, homogeneous and purely elastic, so it is recommended to read about this analysis (see the literature in the References Section 0). This operation only applies to force versus tip-sample separation curves. For these experiments, the tip-sample separation in the indentation part of the curve is then the indentation depth as normally discussed in the literature.

The original Hertz model was an approximation for the contact and very shallow indentation of two spheres in contact. (Hertz 1881). In the AFM literature, however, the term is often used to refer to a family of different models that have been adapted for simple indentation geometries. The key parameter that is usually adapted is the radius of the contact region (see the references Bilodeau 1992, Johnson 1985, Rico et al. 2005, Sneddon 1965).

Parabolic indenter

The original Hertz model is generally valid for a circular paraboloid, and as an approximation for very shallow contact between two spheres.

$$F = \frac{E}{1 - v^2} \frac{4\sqrt{R_c}}{3} \delta^{3/2}$$

$$a = \sqrt{R_c} \delta$$
R_c

F

Α

Spherical indenter

$$F = \frac{E}{1 - v^2} \left[\frac{a^2 + R_s^2}{2} \ln \frac{R_s + a}{R_s - a} - aR_s \right]$$

$$\delta = \frac{a}{2} \ln \frac{R_s + a}{R_s - a}$$

Conical indenter



Four-sided pyramid

We use the Bilodeau formula for pyramidal indenter [1]. Since the Hertz models should all have circular symmetry, an approximation is required for the square-shaped tip. This is a modification to the cone model.



$F = \frac{E}{1 - v^2} 2R_N \delta$ $a = R_N$

F = Force

Flat cylinder

- E = Young's Modulus
- v = Poisson's ratio
- δ = indentation (tip sample separation)
- a = radius of contact circle
- R_C = radius of tip curvature
- R_S = radius of sphere
- R_N = needle radius
- α = half cone angle or face angle of a pyramid
- β = edge angle of a pyramid

Note the differences in the definition of the half-angle for a pyramidal tip. For the cone, there is of course only one halfcone angle. For the square pyramid, the angle can be measured either to the face or to the corner edge of the pyramid. In general, the cone angles from the manufacturers are defined differently for silicon and for silicon nitride tips. In the DP software, there is the possibility to choose which angle is defined.

The geometry is selected in the DP software using the **Tip Shape** selection. For all the different models, the data curve is fitted using a least squares fit with the Levenberg-Marquardt algorithm. The contact point, baseline and Young's modulus values are all fitted simultaneously.



6.7.2 Chain model fit

This section describes the background to the polymer chain fits described in **Section 6.4.7**. The **Freely Jointed Chain** (FJC) and **Worm-Like Chain** (WLC) models are standard models for the entropic elasticity of straightening a polymer chain from a random configuration. Both FJC and WLC are also offered in an **Extensible** version, which includes the effects of directly stretching the chain backbone at higher forces. Janshoff (2000) is an example of a general review.

Chain model fits are used to determine the length and the elastic properties of single molecules or domains being stretched between the tip and sample. These appear as force peaks in the retract curve as a result of unfolding. For these experiments, the tip-sample separation in the adhesive part of the retract curve is the molecule end-to-end length being stretched between tip and sample. To find the best fit, a least squares fit is applied using the Levenberg-Marquardt algorithm.

Freely jointed chain (FJC):



Chain made from rigid links, with free joints between them.

Chain link size (Kuhn length) l_K Contour length $L = n l_K$

End-to-end length x

$$x(F) = L \left[\coth\left(\frac{F l_{K}}{k_{B}T}\right) - \frac{k_{B}T}{F l_{K}} \right]$$

The model can be extended to cover elastic deformation of the backbone, so that it is possible to have an end-to-end length x > L. The equation is modified with a segment elasticity, κ , to become:

$$x(F) = L \left[\coth\left(\frac{F l_{\kappa}}{k_{B}T}\right) - \frac{k_{B}T}{F l_{\kappa}} \right] \left(1 + \frac{F}{\kappa L}\right)$$

Wormlike chain (WLC):



Continuous filament, with resistance to bending.

Average length over which the direction becomes random, (persistence length) l_p

Contour length LEnd-to-end length x

A widely used approximation to the WLC length-force relationship was provided by Marko and Siggia (see the reference Bustamente 1994):

$$F(x) = \frac{k_B T}{l_p} \left[\frac{1}{4} \left(1 - \frac{x}{L} \right)^{-2} + \frac{x}{L} - \frac{1}{4} \right]$$

The maximum error of this interpolation formula is about 10%, but the overall behavior is quite well described. This is the basic WLC model offered in the DP software, as it is the best known.

Bouchiat (1999) suggest a modification that improves the accuracy to 0.01%, with a list of numerical coefficients. This is offered as an alternative fit model in the DP software.

This model can also be extended to include the elasticity of the polymer backbone, in this case the Bustamente version is used.



§ 7 Force Maps and QI data

Force maps and QI data files basically contain the same set of data. The main difference lies in the measurement mode, i.e. the tip motion and velocity, which have been optimized for QI mode. Please read the corresponding sections in the NanoWizard manual for a closer description.

7.1 Opening a JPK force map or QI data file



To open a force map or QI file, select **File > Open** from the pull down **File** menu. Alternatively, click on the open file icon.

Open a JPK data file			×
Look In: 🗀 Manuals 🔹			
	Rename Del	lete	↔ ↔
16x16Map-data-2008.12.18-13	Date	12/8/11 11:39 AM	
16v16Map data 2009 12	Feedback Mode Name	Contact Mode no name entry	
10x10Map-data-2008.12	Account	tneumann	
qi-data-2011.12.08-11.3	1.3 Comment no comment entry Probe		
ci fit 2011 12 08 11 20 2	no probe entry	05.00.05.00	
qi-iit-2011.12.08-11.39.3	Size	25.00 x 25.00 μm	
	Pixels	256 x 256	
	QI Settings	simple	
	Segment	0. Extend	-
	Z Length	0.7 μm 🖌	
	Speed	46.67 μm/s	
	Pixel Num	750	
	Data Rate	50000.000 Hz	
	Duration	0.015 s	
	Total: 4 files Size: 1.1	Gb, 2011.12.08, 12:24	
File <u>Name:</u> qi-data-2011.12.08-1	File Name: qi-data-2011.12.08-11.39.34.jpk-qi-data		
Files of Type: All JPK files	•		
		Op	en Cancel

The options for changing the view and directory are the same as for image files (see **Section 2.1**)

Multiple files in the list can be selected using control-click or shift-click and opened together.



7.1.1 The force map and QI processing window

The processing window contains an image viewer and a force curve window which shows the force curve of the actually selected pixel. The pixel of which the force curve will be displayed can be selected with the mouse. On the right are the register cards for display options and information, for the map/image and the curve respectively.

A thumbnail of each open force map/Qi data file will be shown in the overview window. Each file will be displayed with the original offset used during its acquisition.

7.1.2 The force map/QI data image viewer



The image can display the values for the channels that were recorded with the force map/QI file (by default adhesion, slope, height and height (measured)). The displayed channel can be changed in the **Channel** register card, as well as the **Direction**, **Extend** or **Retract**, from which the values are calculated.

The **View** panel is composed and functioning the same way like the View panel of the data processing window (section 2.3.2).

Use the tick boxes to show the axes including the grid and the color scale. Offset and multiplier can be adjusted (section 2.3.2) using the corresponding sliders. Information about the data range of the map image and the color scale is also given.



Export as Picture Text export Batch processing

<u>L</u> ayout		The	E Layo
<u>C</u> olortable <u>D</u> efault Colortable		colo	ortable
💥 GUI <u>S</u> etting	S		
Channel 🚳 Vie	w 🕕 Info		
Date	12/18/08 12:14 PM		
Feedback Mode:	Contact mode		
Approach Rate:	2.000 Hz		
Approach Speed:	5.0 μm/s		
Retract Rate:	2.000 Hz		
Retract Speed:	5.0 μm/s		
Pause before first:	0.000 s		
Pause at start:	0.000 s		
Pause at end:	0.000 s		
Pause at tipsaver:	0.000 s		
Size:	68.84 x 68.84 μm		
Pixels:	64 × 64		
Approach ID: 2008.12.18-11.5	52.51-00007		
Split map file	:		•
 ForceMap Site 	ngle Index Selection		
🐺 Save Image I	Data	Ctrl-S	

The **Layout** pull down menu allows the choice of different colortables, or the default colortable can be changed for the actual DP session.

The **Info** panel shows general settings used to record the force curves along with the approach ID (section 6.2.3). Also the size and resolution of the map is given.

The **right mouse button menu** provides the different saving options which are also available in the **File** pull down menu (section 0).

7.1.3 The spectroscopy window

Depending on which pixel is selected the corresponding force curve is displayed in the spectroscopy window below the image viewer. The **View** and **Info** panels contain the same display setting options and information about the single force curves as for the normal force curve window (section 6.2). The display toolbar is the same as for batch processing, also containing the additional auto-scale shortcut (section 6.5).



It is not possible to process the force curves as long as they are part of the map. There is an additional **Analyze** panel that allows the analysis of the slope of the indentation part and gives information about the adhesion and relative setpoint values (section 6.4.13) of the currently displayed curve. The values of these four parameters are the ones used for the four different map channels.

If the **Fit Length** is changed, the calculated value for the slope is updated for the currently selected curve. The corresponding color values of the map in the image viewer will not be updated. ForceMap Single Index Selection
 Save Force Scan
 Export as Picture
 Export as Text
 Full Range
 Zoom

The **right mouse button menu** offers the different saving options for force curves and to adjust the display properties.

7.2 Saving options

There are several options for saving data deriving from force maps and QI data. The data can be saved such that it can be reloaded into the DP program or another mathematical standard program, or image files of the force map or force curves can be produced.

Force and QI map data can be saved by using the file pull down menu or the right mouse button menu. The saving options for the force curve window are available in the right mouse button menu.

7.2.1 Save Image Data



To save the map data as an image that can be reloaded into and processed in the DP program, use **Save Image Data** in the right mouse button or the file pull down menu.

🔼 Save Ima	ge Data 🛛 🗙
Save In: 🗀	TestMaps 🔹 🖻 🔀 🔚
 ☐ 6x6Map_8 ☐ optcal-200 	192px-data-2008.12.18-14.08.31)8.12.18-11.59.07
File <u>N</u> ame: Files of <u>T</u> ype:	64x64Map-data-2008.12.18-12.14.55_adhesion_extend.force JPK force map image
	Save

A JPK force map image (filename.force) of the map will be saved or a QI image (qi-fit-filename.jpk-qi-image) respectively. This file contains the values of the active channel together with the spatial information, similar to a normal JPK image.

This image can be reloaded into the DP software selecting **File > Open >** select **Filename.** This image will then be displayed in the standard data processing window (section 2.3) and can be treated and processed like a normal JPK image (see § 3).

7.2.2 Export force maps/QI maps or force curves as picture



The map images and force curves can be exported in PNG or TIFF format, the map images additionally in JPEG and BMP format. The image/curve, exactly as it is displayed in the image viewer/curve window, is exported as an 8-bit file. The current DP settings for axes, color scale etc. are all used for the export.



🔼 Export as Pic	ture	X
Save In: 🗀 Xanthan_Curves		
		Decoration Include filename Transparent background Use a larger font Analysis markers in white Image Size Original size (660x637 pixels) Scaled to C660 pixels
File <u>N</u> ame:	me: force-Xanthan-2004.11.15-19.46.26-0_OldFormat.png	
Files of <u>T</u> ype:	PNG image	•
		Save Cancel

The **Export as Picture** dialog allows many different export options for the graphical image – the file format and content can be modified using the options in this dialog.

The filename can be added as text to the top of the exported image using the tick box here.

A transparent background can be selected. This background may appear black in certain preview programs that do not support transparent format, but in PowerPoint presentations, for instance, this will remove the solid rectangle normally surrounding the image.

7.2.3 Save and export single force curve data

Using **Save Force Scan** in the right mouse button menu, the currently displayed force curve is saved in the normal force curve format (filename.jpk-force for force maps, filename.jpk-qi-series for QI curves) that can be read back into the DP software and processed as described in **Section 6.4** The filename of the produced force file contains the name of the force map/QI map.



data

If the force curve is to be read into another mathematical program, it can be **Exported as text** file, either as out-file (**Export as old force format**) or as **Text dump** (see also **section 6.3.1**). Converting curves into out-files is not recommended, since information will get lost. Text dump export produces text files containing the whole information. In contrast to out-files, text dump files cannot be read back into the DP software.

There is also the possibility to apply the text dump export to the whole map, using the **Text dump** option of the File menu or the right mouse button menu in the map window. Accordingly, the map file is written into a text file containing the whole information.

7.2.4 Split map file

Folder of force curves
 Folder of old ASCII force curves
 Text

The **Split map file** option, available in the **File** menu or the right mouse button menu in the map window, splits the map into a directory of individual force files. The format of the exported files can be selected, as for single force curves:

Folder of force curves writes normal force curves (filnename.jpk-force) in an extra folder that can be specified in the Split map file dialogue.

Force curves of the old force format (filename.out) can be produced using **Folder of old ASCII force curves**.

The **Text** option saves the force curves as normal text files, corresponding to text dump export of single files.

7.3 Batch processing- Force Maps and QI data

Using **Batch processing**, several processing operations can be combined and applied automatically to a large number of force curves (see **Section 6.5**). It is also possible to analyze the different force curves of a force map or QI data file with this process. In each case, the operation functions exactly the same as for individual force curves. The description here is of the batch processing as a whole; please see **Section 6.4** for details of the individual operations.



If the force or QI map is selected in the DP software, **Batch processing** can be started by using this icon or by right click within the force/QI map.

The general opening and handling of Batch processing is described in Section 6.5 and is the same for force maps.



§ 8 References

Bilodeau G.G. (1992) Regular pyramid punch problem. J. Appl. Mech. 59: 512-523.

Bouchiat C., Wang M.D., Allemand J.-F., Strick T., Block S.M. and Croquette V. (1999) "Estimating the persistence length of a worm-like chain molecule from force-extension measurements", *Biophys. J.* 76: 409-413.

Bustamante C., Marko J.F., Siggia E. and Smith S. (1994) "Entropic elasticity of lambda-phage DNA", Science 1599.

Hertz H. (1881) "Über die Berührung fester elastischer Körper" Journal für die angewandte Mathematik 92: 156-171.

Janshoff A., Neitzert M., Obersörfer Y., and Fuchs H. (2000) "Force Spectroscopy of molecular systems – single molecule spectroscopy of polymers and biomolecules". *Angew. Chem. Int. Ed.* 39:3212-3237.

Johnson K.L. (1985) "Contact Mechanics" Cambridge University Press: Cambridge, UK, ISBN 0-521-34796-3

Kerssemakers J.W.J., Munteanu E.L., Laan L., Noetzel T.L., Janson M.E. and Dogterom M. (2006) "Assembly dynamics of microtubules at molecular resolution". *Nature* 442: 709-712.

Ogden R.W., Saccomandi G. and Sgura, I. (2007) "Computational aspects of worm-like-chain interpolation formulas", *Comp. Math. Appl.* 53: 276–286.

Rico F., Roca-Cusachs P., Gavara N., Farré R., Rotger M., Navajas D. (2005) "Probing mechanical properties of living cell by atomic force microscopy with blunted pyramidal cantilever tips" *Phys. Rev. E* 72: 021914-1-10.

Sneddon I.N. (1965) "The relation between load and penetration in the axisymmetric Boussinesq problem for a punch of arbitrary profile" *Int. J. Engn. Sci.* 3: 47-57.

Note: All trademarked names mentioned in this manual remain the exclusive property of their respective owners.

JPK Instruments AG Bouchéstrasse 12 12435 Berlin Germany

Tel: +49 30 5331 12070 Fax: +49 30 5331 22555 support@jpk.com www.jpk.com

JPK-DOC0070

All rights reserved.